

TMUX6219 具有 1.8V 逻辑电平的 36V、低 Ron、2:1 (SPDT) 开关

1 特性

- 双电源电压范围 : $\pm 4.5V$ 至 $\pm 18V$
- 单电源电压范围 : $4.5V$ 至 $36V$
- 低导通电阻 : 2.1Ω
- 低电荷注入 : $-10pC$
- 大电流支持 : $330mA$ (最大值) (VSSOP)
- 大电流支持 : $440mA$ (最大值) (WSON)
- $40^\circ C$ 至 $+125^\circ C$ 工作温度
- 兼容 1.8V 逻辑电平
- 失效防护逻辑
- 轨到轨运行
- 双向信号路径
- 先断后合开关

2 应用

- 工厂自动化和工业控制
- 可编程逻辑控制器 (PLC)
- 模拟输入模块
- 半导体测试
- 交流充电 (桩) 站
- 超声波扫描仪
- 患者监护和诊断
- 光纤网络
- 光学测试设备
- 远程无线电单元
- 有线网络
- 数据采集系统
- 燃气表
- 流量变送器

3 说明

TMUX6219 是一款的互补金属氧化物半导体 (CMOS) 开关，采用单通道 2:1 (SPDT) 配置。此器件在单电源 ($4.5V$ 至 $36V$)、双电源 ($\pm 4.5V$ 至 $\pm 18V$) 或非对称电源 (例如 $V_{DD} = 5V$, $V_{SS} = -8V$) 供电时均能正常运行。TMUX6219 可在源极 (Sx) 和漏极 (D) 引脚上支持 V_{SS} 到 V_{DD} 范围的双向模拟和数字信号。

可以通过控制 EN 引脚来启用或禁用 TMUX6219。当禁用时，两个信号路径开关都被关闭。当启用时，SEL 引脚可用于打开信号路径 1 (S1 至 D) 或信号路径 2 (S2 至 D)。所有逻辑控制输入均支持 1.8V 到 V_{DD} 的逻辑电平，因此，当器件在有效电源电压范围内运行时，可确保 TTL 和 CMOS 逻辑兼容性。失效防护逻辑电路允许先在控制引脚上施加电压，然后在电源引脚上施加电压，从而保护器件免受潜在的损害。

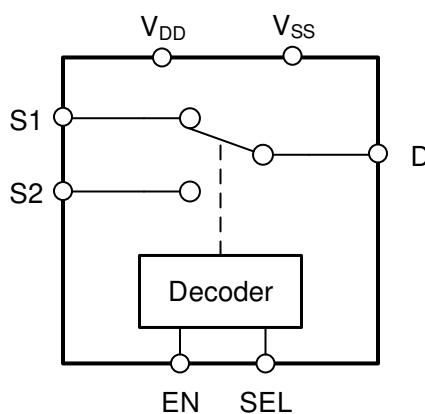
TMUX6219 属于精密开关和多路复用器器件系列。这些器件具有非常低的导通和关断漏电流以及低电荷注入，因此可用于高精度测量应用。

封装信息

器件型号	封装 ⁽¹⁾	封装尺寸 ⁽²⁾
TMUX6219	DGK (VSSOP, 8)	$3mm \times 4.9mm$
	RQX (WSOP, 8)	$2mm \times 3mm$

(1) 有关更多信息，请参阅 [节 13](#)

(2) 封装尺寸 (长 × 宽) 为标称值，并包括引脚 (如适用)。



TMUX6219 方框图

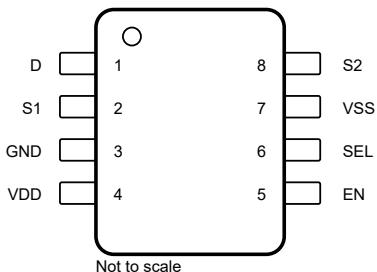


本资源的原文使用英文撰写。为方便起见，TI 提供了译文；由于翻译过程中可能使用了自动化工具，TI 不保证译文的准确性。为确认准确性，请务必访问 ti.com 参考最新的英文版本 (控制文档)。

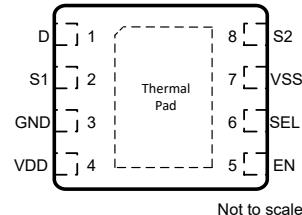
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4 Pin Configuration and Functions



**图 4-1. DGK Package,
8-Pin VSSOP
(Top View)**



**图 4-2. RQX Package,
8-Pin WSON
(Top View)**

表 4-1. Pin Functions

PIN			TYPE ⁽¹⁾	DESCRIPTION ⁽²⁾
NAME	DGK	RQX		
D	1	1	I/O	Drain pin. Can be an input or output.
S1	2	2	I/O	Source pin 1. Can be an input or output.
GND	3	3	P	Ground (0V) reference
V _{DD}	4	4	P	Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 0.1µF to 10µF between V _{DD} and GND.
EN	5	5	I	Active high logic enable, has internal pull-up resistor. When this pin is low, all switches are turned off. When this pin is high, the SEL logic input determine which switch is turned on.
SEL	6	6	I	Logic control input, has internal pull-down resistor. Controls the switch connection as shown in 节 7.5 .
V _{SS}	7	7	P	Negative power supply. This pin is the most negative power-supply potential. In single-supply applications, this pin can be connected to ground. For reliable operation, connect a decoupling capacitor ranging from 0.1µF to 10µF between V _{SS} and GND.
S2	8	8	I/O	Source pin 2. Can be an input or output.
Thermal Pad			—	The thermal pad is not connected internally. It is recommended that the pad be tied to GND or VSS for best performance.

(1) I = input, O = output, I/O = input and output, P = power.

(2) Refer to [节 7.4](#) for what to do with unused pins.

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)^{(1) (2)}

		MIN	MAX	UNIT
$V_{DD} - V_{SS}$	Supply voltage		38	V
V_{DD}		- 0.5	38	V
V_{SS}		- 38	0.5	V
V_{SEL} or V_{EN}	Logic control input pin voltage (SEL, EN) ⁽³⁾		- 0.5	V
I_{SEL} or I_{EN}	Logic control input pin current (SEL, EN) ⁽³⁾		- 30	mA
V_S or V_D	Source or drain voltage (Sx, D) ⁽³⁾		$V_{SS} - 0.5$	$V_{DD} + 0.5$
I_{IK}	Diode clamp current ⁽³⁾		- 30	mA
I_S or I_D (CONT)	Source or drain continuous current (Sx, D)			$I_{DC} + 10\%^{(4)}$
T_A	Ambient temperature		- 55	°C
T_{stg}	Storage temperature		- 65	°C
T_J	Junction temperature			150
P_{tot}	Total power dissipation (DGK Package) ⁽⁵⁾			460
	Total power dissipation (RQX Package) ⁽⁶⁾			1110

- (1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to ground, unless otherwise specified.
- (3) Pins are diode-clamped to the power-supply rails. Over voltage signals must be voltage and current limited to maximum ratings.
- (4) Refer to *Source or Drain Continuous Current* table for I_{DC} specifications.
- (5) For DGK package: P_{tot} derates linearly above $T_A = 70^\circ\text{C}$ by 6.7mW/°C.
- (6) For RQX package: P_{tot} derates linearly above $T_A = 70^\circ\text{C}$ by 16mW/°C.

5.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	± 2000
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	± 500

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

5.3 Thermal Information

THERMAL METRIC ⁽¹⁾		TMUX6219	TMUX6219	UNIT
		DGK (VSSOP)	RQX (WSON)	
		8 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	152.1	62.9	°C/W
$R_{\theta JC(\text{top})}$	Junction-to-case (top) thermal resistance	48.4	54.0	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	73.2	31.0	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	4.1	0.8	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	71.8	30.9	°C/W

THERMAL METRIC ⁽¹⁾		TMUX6219	TMUX6219	UNIT
		DGK (VSSOP)	RQX (WSON)	
		8 PINS	8 PINS	
$R_{\theta, JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	23.4	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

5.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
$V_{DD} - V_{SS}$ ⁽¹⁾	Power supply voltage differential	4.5	36	36	V
V_{DD}	Positive power supply voltage	4.5	36	36	V
V_S or V_D	Signal path input/output voltage (source or drain pin) (Sx, D)	V_{SS}	V_{DD}	V_{DD}	V
V_{SEL} or V_{EN}	Address or enable pin voltage	0	36	36	V
I_S or I_D (CONT)	Source or drain continuous current (Sx, D)			I_{DC} ⁽²⁾	mA
T_A	Ambient temperature	- 40	125	125	°C

(1) V_{DD} and V_{SS} can be any value as long as $4.5 \text{ V} \leq (V_{DD} - V_{SS}) \leq 36 \text{ V}$, and the minimum V_{DD} is met.

(2) Refer to *Source or Drain Continuous Current* table for I_{DC} specifications.

5.5 Source or Drain Continuous Current

at supply voltage of $V_{DD} \pm 10\%$, $V_{SS} \pm 10\%$ (unless otherwise noted)

CONTINUOUS CURRENT PER CHANNEL (I_{DC})		$T_A = 25^\circ\text{C}$	$T_A = 85^\circ\text{C}$	$T_A = 125^\circ\text{C}$	UNIT
PACKAGE	TEST CONDITIONS				
RQX (WSON)	$\pm 15 \text{ V}$ Dual Supply	440	270	130	mA
	+36 V Single Supply ⁽¹⁾	440	270	130	mA
	+12 V Single Supply	330	200	105	mA
	$\pm 5 \text{ V}$ Dual Supply	330	200	105	mA
	+5 V Single Supply	230	140	90	mA
DGK (VSSOP)	$\pm 15 \text{ V}$ Dual Supply	330	210	120	mA
	+36 V Single Supply ⁽¹⁾	300	190	110	mA
	+12 V Single Supply	240	160	100	mA
	$\pm 5 \text{ V}$ Dual Supply	240	160	100	mA
	+5 V Single Supply	180	120	80	mA

(1) Specified for nominal supply voltage only.

5.6 ± 15 V Dual Supply: Electrical Characteristics

$V_{DD} = +15$ V $\pm 10\%$, $V_{SS} = -15$ V $\pm 10\%$, GND = 0 V (unless otherwise noted)

Typical at $V_{DD} = +15$ V, $V_{SS} = -15$ V, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	$V_S = -10$ V to $+10$ V $I_D = -10$ mA Refer to On-Resistance	25°C	2.1	2.9	Ω	
			-40°C to +85°C		3.8	Ω	
			-40°C to +125°C		4.5	Ω	
ΔR_{ON}	On-resistance mismatch between channels	$V_S = -10$ V to $+10$ V $I_D = -10$ mA Refer to On-Resistance	25°C	0.05	0.25	Ω	
			-40°C to +85°C		0.3	Ω	
			-40°C to +125°C		0.35	Ω	
$R_{ON\,FLAT}$	On-resistance flatness	$V_S = -10$ V to $+10$ V $I_S = -10$ mA Refer to On-Resistance	25°C	0.5	0.6	Ω	
			-40°C to +85°C		0.7	Ω	
			-40°C to +125°C		0.85	Ω	
$R_{ON\,DRIFT}$	On-resistance drift	$V_S = 0$ V, $I_S = -10$ mA Refer to On-Resistance	-40°C to +125°C	0.01			$\Omega/^\circ\text{C}$
$I_{S(OFF)}$	Source off leakage current ⁽¹⁾	$V_{DD} = 16.5$ V, $V_{SS} = -16.5$ V Switch state is off $V_S = +10$ V / -10 V $V_D = -10$ V / +10 V Refer to Off-Leakage Current	25°C	-0.2	0.05	0.2	nA
			-40°C to +85°C	-1.6		1.6	nA
			-40°C to +125°C	-40		40	nA
$I_{D(OFF)}$	Drain off leakage current ⁽¹⁾	$V_{DD} = 16.5$ V, $V_{SS} = -16.5$ V Switch state is off $V_S = +10$ V / -10 V $V_D = -10$ V / +10 V Refer to Off-Leakage Current	25°C	-1	0.05	1	nA
			-40°C to +85°C	-3		3	nA
			-40°C to +125°C	-60		60	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current ⁽²⁾	$V_{DD} = 16.5$ V, $V_{SS} = -16.5$ V Switch state is on $V_S = V_D = \pm 10$ V Refer to On-Leakage Current	25°C	-1	0.04	1	nA
			-40°C to +85°C	-2		2	nA
			-40°C to +125°C	-50		50	nA
LOGIC INPUTS (SEL / EN pins)							
V_{IH}	Logic voltage high		-40°C to +125°C	1.3	36	36	V
V_{IL}	Logic voltage low		-40°C to +125°C	0	0.8	0.8	V
I_{IH}	Input leakage current		-40°C to +125°C		0.005	2	μA
I_{IL}	Input leakage current		-40°C to +125°C	-1	-0.005		μA
C_{IN}	Logic input capacitance		-40°C to +125°C		3		pF
POWER SUPPLY							
I_{DD}	V_{DD} supply current	$V_{DD} = 16.5$ V, $V_{SS} = -16.5$ V Logic inputs = 0 V, 5 V, or V_{DD}	25°C	30	40	μA	
			-40°C to +85°C		48	μA	
			-40°C to +125°C		62	μA	
I_{SS}	V_{SS} supply current	$V_{DD} = 16.5$ V, $V_{SS} = -16.5$ V Logic inputs = 0 V, 5 V, or V_{DD}	25°C	3	10	μA	
			-40°C to +85°C		15	μA	
			-40°C to +125°C		25	μA	

(1) When V_S is positive, V_D is negative, or when V_S is negative, V_D is positive.

(2) When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.

5.7 ± 15 V Dual Supply: Switching Characteristics

$V_{DD} = +15 \text{ V} \pm 10\%$, $V_{SS} = -15 \text{ V} \pm 10\%$, GND = 0 V (unless otherwise noted)

Typical at $V_{DD} = +15 \text{ V}$, $V_{SS} = -15 \text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
t_{TRAN}	Transition time from control input	$V_S = 10 \text{ V}$ $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Transition Time	25°C		120	175	ns
			- 40°C to +85°C		190		ns
			- 40°C to +125°C		210		ns
$t_{ON \text{ (EN)}}$	Turn-on time from enable	$V_S = 10 \text{ V}$ $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Turn-on and Turn-off Time	25°C		100	170	ns
			- 40°C to +85°C		185		ns
			- 40°C to +125°C		200		ns
$t_{OFF \text{ (EN)}}$	Turn-off time from enable	$V_S = 10 \text{ V}$ $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Turn-on and Turn-off Time	25°C		100	180	ns
			- 40°C to +85°C		195		ns
			- 40°C to +125°C		210		ns
t_{BBM}	Break-before-make time delay	$V_S = 10 \text{ V}$, $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Break-Before-Make	25°C		50		ns
			- 40°C to +85°C		1		ns
			- 40°C to +125°C		1		ns
$T_{ON \text{ (VDD)}}$	Device turn on time (V_{DD} to output)	V_{DD} rise time = 100 ns $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Turn-on (VDD) Time	25°C		0.19		ms
			- 40°C to +85°C		0.2		ms
			- 40°C to +125°C		0.2		ms
t_{PD}	Propagation delay	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ Refer to Propagation Delay	25°C		700		ps
Q_{INJ}	Charge injection	$V_D = 0 \text{ V}$, $C_L = 1 \text{ nF}$ Refer to Charge Injection	25°C		- 10		pC
O_{ISO}	Off-isolation	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$, $f = 100 \text{ kHz}$ Refer to Off Isolation	25°C		- 75		dB
O_{ISO}	Off-isolation	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$ Refer to Off Isolation	25°C		- 55		dB
X_{TALK}	Crosstalk	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$, $f = 100 \text{ kHz}$ Refer to Crosstalk	25°C		- 117		dB
X_{TALK}	Crosstalk	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$ Refer to Crosstalk	25°C		- 106		dB
BW	- 3dB Bandwidth	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$ Refer to Bandwidth	25°C		40		MHz
I_L	Insertion loss	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$	25°C		- 0.18		dB
$ACPSRR$	AC Power Supply Rejection Ratio	$V_{PP} = 0.62 \text{ V}$ on V_{DD} and V_{SS} $R_L = 50 \Omega$, $C_L = 5 \text{ pF}$, $f = 1 \text{ MHz}$ Refer to ACPSRR	25°C		- 64		dB
$THD+N$	Total Harmonic Distortion + Noise	$V_{PP} = 15 \text{ V}$, $V_{BIAS} = 0 \text{ V}$ $R_L = 10 \text{ k}\Omega$, $C_L = 5 \text{ pF}$, $f = 20 \text{ Hz}$ to 20 kHz Refer to THD + Noise	25°C		0.0005		%
$C_{S(OFF)}$	Source off capacitance	$V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$	25°C		33		pF
$C_{D(OFF)}$	Drain off capacitance	$V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$	25°C		48		pF

$V_{DD} = +15 \text{ V} \pm 10\%$, $V_{SS} = -15 \text{ V} \pm 10\%$, GND = 0 V (unless otherwise noted)

Typical at $V_{DD} = +15 \text{ V}$, $V_{SS} = -15 \text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
$C_{S(ON)}$, $C_{D(ON)}$	On capacitance	$V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$	25°C	148		pF

5.8 36 V Single Supply: Electrical Characteristics

$V_{DD} = +36 V \pm 10\%$, $V_{SS} = 0 V$, $GND = 0 V$ (unless otherwise noted)

Typical at $V_{DD} = +36 V$, $V_{SS} = 0 V$, $T_A = 25^\circ C$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	$V_S = 0 V$ to $30 V$ $I_D = -10 mA$ Refer to On-Resistance	25°C	2.5	3.2	Ω	
			-40°C to +85°C		4.2	Ω	
			-40°C to +125°C		4.9	Ω	
ΔR_{ON}	On-resistance mismatch between channels	$V_S = 0 V$ to $30 V$ $I_D = -10 mA$ Refer to On-Resistance	25°C	0.1	0.2	Ω	
			-40°C to +85°C		0.25	Ω	
			-40°C to +125°C		0.3	Ω	
$R_{ON\ FLAT}$	On-resistance flatness	$V_S = 0 V$ to $30 V$ $I_S = -10 mA$ Refer to On-Resistance	25°C	0.3	1	Ω	
			-40°C to +85°C		1.5	Ω	
			-40°C to +125°C		2	Ω	
$R_{ON\ DRIFT}$	On-resistance drift	$V_S = 18 V$, $I_S = -10 mA$ Refer to On-Resistance	-40°C to +125°C	0.009			$\Omega/^\circ C$
$I_{S(OFF)}$	Source off leakage current ⁽¹⁾	$V_{DD} = 39.6 V$, $V_{SS} = 0 V$ Switch state is off $V_S = 30 V$ / $1 V$ $V_D = 1 V$ / $30 V$ Refer to Off-Leakage Current	25°C	-0.3	0.05	0.3	nA
			-40°C to +85°C	-3.5		3.5	nA
			-40°C to +125°C	-60		60	nA
$I_{D(OFF)}$	Drain off leakage current ⁽¹⁾	$V_{DD} = 39.6 V$, $V_{SS} = 0 V$ Switch state is off $V_S = 30 V$ / $1 V$ $V_D = 1 V$ / $30 V$ Refer to Off-Leakage Current	25°C	-1	0.05	1	nA
			-40°C to +85°C	-6.2		6.2	nA
			-40°C to +125°C	-80		80	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current ⁽²⁾	$V_{DD} = 39.6 V$, $V_{SS} = 0 V$ Switch state is on $V_S = V_D = 30 V$ or $1 V$ Refer to On-Leakage Current	25°C	-0.4	0.05	0.4	nA
			-40°C to +85°C	-4.5		4.5	nA
			-40°C to +125°C	-70		70	nA
LOGIC INPUTS (SEL / EN pins)							
V_{IH}	Logic voltage high		-40°C to +125°C	1.3	36	V	
V_{IL}	Logic voltage low		-40°C to +125°C	0	0.8	V	
I_{IH}	Input leakage current		-40°C to +125°C	0.005	2	μA	
I_{IL}	Input leakage current		-40°C to +125°C	-1	-0.005	μA	
C_{IN}	Logic input capacitance		-40°C to +125°C	3		pF	
POWER SUPPLY							
I_{DD}	V_{DD} supply current	$V_{DD} = 39.6 V$, $V_{SS} = 0 V$ Logic inputs = $0 V$, $5 V$, or V_{DD}	25°C	28	50	μA	
			-40°C to +85°C		58	μA	
			-40°C to +125°C		70	μA	

(1) When V_S is $30 V$, V_D is $1 V$, or when V_S is $1 V$, V_D is $30 V$.

(2) When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.

5.9 36 V Single Supply: Switching Characteristics

$V_{DD} = +36 V \pm 10\%$, $V_{SS} = 0 V$, $GND = 0 V$ (unless otherwise noted)

Typical at $V_{DD} = +36 V$, $V_{SS} = 0 V$, $T_A = 25^\circ C$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
t_{TRAN}	Transition time from control input	$V_S = 18 V$ $R_L = 300 \Omega$, $C_L = 35 pF$ Refer to Transition Time	25°C	110	170	ns	
			-40°C to +85°C		185	ns	
			-40°C to +125°C		200	ns	
$t_{ON (EN)}$	Turn-on time from enable	$V_S = 18 V$ $R_L = 300 \Omega$, $C_L = 35 pF$ Refer to Turn-on and Turn-off Time	25°C	110	180	ns	
			-40°C to +85°C		190	ns	
			-40°C to +125°C		200	ns	
$t_{OFF (EN)}$	Turn-off time from enable	$V_S = 18 V$ $R_L = 300 \Omega$, $C_L = 35 pF$ Refer to Turn-on and Turn-off Time	25°C	90	180	ns	
			-40°C to +85°C		195	ns	
			-40°C to +125°C		200	ns	
t_{BBM}	Break-before-make time delay	$V_S = 18 V$, $R_L = 300 \Omega$, $C_L = 35 pF$ Refer to Break-Before-Make	25°C	44		ns	
			-40°C to +85°C	1		ns	
			-40°C to +125°C	1		ns	
$T_{ON (VDD)}$	Device turn on time (V_{DD} to output)	V_{DD} rise time = 100 ns $R_L = 300 \Omega$, $C_L = 35 pF$ Refer to Turn-on (VDD) Time	25°C	0.17		ms	
			-40°C to +85°C	0.19		ms	
			-40°C to +125°C	0.19		ms	
t_{PD}	Propagation delay	$R_L = 50 \Omega$, $C_L = 5 pF$ Refer to Propagation Delay	25°C	920		ps	
Q_{INJ}	Charge injection	$V_D = 18 V$, $C_L = 1 nF$ Refer to Charge Injection	25°C	-13		pC	
O_{ISO}	Off-isolation	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 6 V$, $f = 100 kHz$ Refer to Off Isolation	25°C	-75		dB	
O_{ISO}	Off-isolation	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 6 V$, $f = 1 MHz$ Refer to Off Isolation	25°C	-55		dB	
X_{TALK}	Crosstalk	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 6 V$, $f = 100 kHz$ Refer to Crosstalk	25°C	-117		dB	
X_{TALK}	Crosstalk	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 6 V$, $f = 1 MHz$ Refer to Crosstalk	25°C	-106		dB	
BW	-3dB Bandwidth	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 6 V$, Refer to Bandwidth	25°C	38		MHz	
I_L	Insertion loss	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 6 V$, $f = 1 MHz$	25°C	-0.19		dB	
$ACPSRR$	AC Power Supply Rejection Ratio	$V_{PP} = 0.62 V$ on V_{DD} and V_{SS} $R_L = 50 \Omega$, $C_L = 5 pF$, $f = 1 MHz$ Refer to ACPSRR	25°C	-60		dB	
$THD+N$	Total Harmonic Distortion + Noise	$V_{PP} = 18 V$, $V_{BIAS} = 18 V$ $R_L = 10 k\Omega$, $C_L = 5 pF$, $f = 20 Hz$ to $20 kHz$ Refer to THD + Noise	25°C	0.0004		%	
$C_{S(OFF)}$	Source off capacitance	$V_S = 6 V$, $f = 1 MHz$	25°C	35		pF	
$C_{D(OFF)}$	Drain off capacitance	$V_S = 6 V$, $f = 1 MHz$	25°C	49		pF	

$V_{DD} = +36 \text{ V} \pm 10\%$, $V_{SS} = 0 \text{ V}$, $\text{GND} = 0 \text{ V}$ (unless otherwise noted)

Typical at $V_{DD} = +36 \text{ V}$, $V_{SS} = 0 \text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
$C_{S(ON)}$, $C_{D(ON)}$	On capacitance	$V_S = 6 \text{ V}$, $f = 1 \text{ MHz}$	25°C	146		pF

5.10 12 V Single Supply: Electrical Characteristics

$V_{DD} = +12 \text{ V} \pm 10\%$, $V_{SS} = 0 \text{ V}$, $GND = 0 \text{ V}$ (unless otherwise noted)

Typical at $V_{DD} = +12 \text{ V}$, $V_{SS} = 0 \text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	$V_S = 0 \text{ V}$ to 10 V $I_D = -10 \text{ mA}$ Refer to On-Resistance	25°C	4.6	6	Ω	
			-40°C to +85°C		7.5	Ω	
			-40°C to +125°C		8.4	Ω	
ΔR_{ON}	On-resistance mismatch between channels	$V_S = 0 \text{ V}$ to 10 V $I_D = -10 \text{ mA}$ Refer to On-Resistance	25°C	0.08	0.2	Ω	
			-40°C to +85°C		0.32	Ω	
			-40°C to +125°C		0.35	Ω	
$R_{ON\ FLAT}$	On-resistance flatness	$V_S = 0 \text{ V}$ to 10 V $I_S = -10 \text{ mA}$ Refer to On-Resistance	25°C	1.2	2	Ω	
			-40°C to +85°C		2.2	Ω	
			-40°C to +125°C		2.4	Ω	
$R_{ON\ DRIFT}$	On-resistance drift	$V_S = 6 \text{ V}$, $I_S = -10 \text{ mA}$ Refer to On-Resistance	-40°C to +125°C	0.017			$\Omega/\text{°C}$
$I_{S(OFF)}$	Source off leakage current ⁽¹⁾	$V_{DD} = 13.2 \text{ V}$, $V_{SS} = 0 \text{ V}$ Switch state is off $V_S = 10 \text{ V}$ / 1 V $V_D = 1 \text{ V}$ / 10 V Refer to Off-Leakage Current	25°C	-0.5	0.05	0.5	nA
			-40°C to +85°C	-2		2	nA
			-40°C to +125°C	-30		30	nA
$I_{D(OFF)}$	Drain off leakage current ⁽¹⁾	$V_{DD} = 13.2 \text{ V}$, $V_{SS} = 0 \text{ V}$ Switch state is off $V_S = 10 \text{ V}$ / 1 V $V_D = 1 \text{ V}$ / 10 V Refer to Off-Leakage Current	25°C	-0.5	0.05	0.5	nA
			-40°C to +85°C	-3		3	nA
			-40°C to +125°C	-50		50	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current ⁽²⁾	$V_{DD} = 13.2 \text{ V}$, $V_{SS} = 0 \text{ V}$ Switch state is on $V_S = V_D = 10 \text{ V}$ or 1 V Refer to On-Leakage Current	25°C	-1.5	0.05	1.5	nA
			-40°C to +85°C	-3		3	nA
			-40°C to +125°C	-40		40	nA
LOGIC INPUTS (SEL / EN pins)							
V_{IH}	Logic voltage high		-40°C to +125°C	1.3	36	V	
V_{IL}	Logic voltage low		-40°C to +125°C	0	0.8	V	
I_{IH}	Input leakage current		-40°C to +125°C	0.005	2	μA	
I_{IL}	Input leakage current		-40°C to +125°C	-1	-0.005	μA	
C_{IN}	Logic input capacitance		-40°C to +125°C	3		pF	
POWER SUPPLY							
I_{DD}	V_{DD} supply current	$V_{DD} = 13.2 \text{ V}$, $V_{SS} = 0 \text{ V}$ Logic inputs = 0 V, 5 V, or V_{DD}	25°C	10	35	μA	
			-40°C to +85°C		45	μA	
			-40°C to +125°C		55	μA	

(1) When V_S is 10 V, V_D is 1 V, or when V_S is 1 V, V_D is 10 V.

(2) When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.

5.11 12 V Single Supply: Switching Characteristics

$V_{DD} = +12 \text{ V} \pm 10\%$, $V_{SS} = 0 \text{ V}$, $GND = 0 \text{ V}$ (unless otherwise noted)

Typical at $V_{DD} = +12 \text{ V}$, $V_{SS} = 0 \text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
t_{TRAN}	Transition time from control input	$V_S = 8 \text{ V}$ $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Transition Time	25°C	180	185	ns	
			- 40°C to +85°C		215	ns	
			- 40°C to +125°C		235	ns	
$t_{ON \ (EN)}$	Turn-on time from enable	$V_S = 8 \text{ V}$ $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Turn-on and Turn-off Time	25°C	120	180	ns	
			- 40°C to +85°C		210	ns	
			- 40°C to +125°C		230	ns	
$t_{OFF \ (EN)}$	Turn-off time from enable	$V_S = 8 \text{ V}$ $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Turn-on and Turn-off Time	25°C	130	210	ns	
			- 40°C to +85°C		235	ns	
			- 40°C to +125°C		250	ns	
t_{BBM}	Break-before-make time delay	$V_S = 8 \text{ V}$, $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Break-Before-Make	25°C	40	40	ns	
			- 40°C to +85°C	1	1	ns	
			- 40°C to +125°C	1	1	ns	
$T_{ON \ (VDD)}$	Device turn on time (V_{DD} to output)	V_{DD} rise time = 100 ns $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Turn-on (VDD) Time	25°C	0.19	0.19	ms	
			- 40°C to +85°C	0.2	0.2	ms	
			- 40°C to +125°C	0.2	0.2	ms	
t_{PD}	Propagation delay	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ Refer to Propagation Delay	25°C	740	740	ps	
Q_{INJ}	Charge injection	$V_D = 6 \text{ V}$, $C_L = 1 \text{ nF}$ Refer to Charge Injection	25°C	- 6	- 6	pC	
O_{ISO}	Off-isolation	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 6 \text{ V}$, $f = 100 \text{ kHz}$ Refer to Off Isolation	25°C	- 75	- 75	dB	
O_{ISO}	Off-isolation	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 6 \text{ V}$, $f = 1 \text{ MHz}$ Refer to Off Isolation	25°C	- 55	- 55	dB	
X_{TALK}	Crosstalk	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 6 \text{ V}$, $f = 100 \text{ kHz}$ Refer to Crosstalk	25°C	- 117	- 117	dB	
X_{TALK}	Crosstalk	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 6 \text{ V}$, $f = 1 \text{ MHz}$ Refer to Crosstalk	25°C	- 106	- 106	dB	
BW	- 3dB Bandwidth	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 6 \text{ V}$ Refer to Bandwidth	25°C	42	42	MHz	
I_L	Insertion loss	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 6 \text{ V}$, $f = 1 \text{ MHz}$	25°C	- 0.3	- 0.3	dB	
$ACPSRR$	AC Power Supply Rejection Ratio	$V_{PP} = 0.62 \text{ V}$ on V_{DD} and V_{SS} $R_L = 50 \Omega$, $C_L = 5 \text{ pF}$, $f = 1 \text{ MHz}$ Refer to ACPSRR	25°C	- 65	- 65	dB	
$THD+N$	Total Harmonic Distortion + Noise	$V_{PP} = 6 \text{ V}$, $V_{BIAS} = 6 \text{ V}$ $R_L = 10 \text{ k}\Omega$, $C_L = 5 \text{ pF}$, $f = 20 \text{ Hz}$ to 20 kHz Refer to THD + Noise	25°C	0.0009	0.0009	%	
$C_{S(OFF)}$	Source off capacitance	$V_S = 6 \text{ V}$, $f = 1 \text{ MHz}$	25°C	38	38	pF	
$C_{D(OFF)}$	Drain off capacitance	$V_S = 6 \text{ V}$, $f = 1 \text{ MHz}$	25°C	56	56	pF	

$V_{DD} = +12 \text{ V} \pm 10\%$, $V_{SS} = 0 \text{ V}$, $GND = 0 \text{ V}$ (unless otherwise noted)

Typical at $V_{DD} = +12 \text{ V}$, $V_{SS} = 0 \text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
$C_{S(ON)}$, $C_{D(ON)}$	On capacitance	$V_S = 6 \text{ V}$, $f = 1 \text{ MHz}$	25°C	150		pF

5.12 +5 V / -8 V Dual Supply: Electrical Characteristics

$V_{DD} = +5 \text{ V} \pm 10\%$, $V_{SS} = -8 \text{ V} \pm 10\%$, $GND = 0 \text{ V}$ (unless otherwise noted)

Typical at $V_{DD} = +5 \text{ V}$, $V_{SS} = -5 \text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	$V_{DD} = +5 \text{ V}$, $V_{SS} = -8 \text{ V}$ $V_S = V_{DD} \text{ to } V_{SS}$ $I_D = -10 \text{ mA}$ Refer to On-Resistance	25°C	4.2	5.5	Ω	
			-40°C to +85°C		6.8	Ω	
			-40°C to +125°C		7.6	Ω	
ΔR_{ON}	On-resistance mismatch between channels	$V_S = V_{DD} \text{ to } V_{SS}$ $I_D = -10 \text{ mA}$ Refer to On-Resistance	25°C	0.1	0.23	Ω	
			-40°C to +85°C		0.27	Ω	
			-40°C to +125°C		0.35	Ω	
$R_{ON\ FLAT}$	On-resistance flatness	$V_S = V_{DD} \text{ to } V_{SS}$ $I_D = -10 \text{ mA}$ Refer to On-Resistance	25°C	1	1.5	Ω	
			-40°C to +85°C		1.7	Ω	
			-40°C to +125°C		2	Ω	
$R_{ON\ DRIFT}$	On-resistance drift	$V_S = 0 \text{ V}$, $I_S = -10 \text{ mA}$ Refer to On-Resistance	-40°C to +125°C	0.019		$\Omega/\text{°C}$	
$I_{S(OFF)}$	Source off leakage current ⁽¹⁾	$V_{DD} = +5.5 \text{ V}$, $V_{SS} = -8.8 \text{ V}$ Switch state is off $V_S = V_{DD} - 1 / V_{SS} + 1$ $V_D = V_{SS} + 1 / V_{DD} - 1$ Refer to Off-Leakage Current	25°C	-0.3	0.1	0.3	nA
			-40°C to +85°C	-3		3	nA
			-40°C to +125°C	-50		50	nA
$I_{D(OFF)}$	Drain off leakage current ⁽¹⁾	$V_{DD} = +5.5 \text{ V}$, $V_{SS} = -8.8 \text{ V}$ Switch state is off $V_S = V_{DD} - 1 / V_{SS} + 1$ $V_D = V_{SS} + 1 / V_{DD} - 1$ Refer to Off-Leakage Current	25°C	-0.5	0.1	0.5	nA
			-40°C to +85°C	-3		3	nA
			-40°C to +125°C	-55		55	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current ⁽²⁾	$V_{DD} = +5.5 \text{ V}$, $V_{SS} = -8.8 \text{ V}$ Switch state is on $V_S = V_D = V_{DD} - 1 / V_{SS} + 1$ Refer to On-Leakage Current	25°C	-0.5	0.1	0.5	nA
			-40°C to +85°C	-3		3	nA
			-40°C to +125°C	-40		40	nA
LOGIC INPUTS (SEL / EN pins)							
V_{IH}	Logic voltage high		-40°C to +125°C	1.3	44	V	
V_{IL}	Logic voltage low		-40°C to +125°C	0	0.8	V	
I_{IH}	Input leakage current		-40°C to +125°C	0.005	2	μA	
I_{IL}	Input leakage current		-40°C to +125°C	-1	-0.005		μA
C_{IN}	Logic input capacitance		-40°C to +125°C	3			pF
POWER SUPPLY							
I_{DD}	V_{DD} supply current	$V_{DD} = +5.5 \text{ V}$, $V_{SS} = -8.8 \text{ V}$ Logic inputs = 0 V, 5 V, or V_{DD}	25°C	24	30	μA	
			-40°C to +85°C		37	μA	
			-40°C to +125°C		42	μA	
I_{SS}	V_{SS} supply current	$V_{DD} = +5.5 \text{ V}$, $V_{SS} = -8.8 \text{ V}$ Logic inputs = 0 V, 5 V, or V_{DD}	25°C	1	5	μA	
			-40°C to +85°C		8	μA	
			-40°C to +125°C		12	μA	

(1) When V_S is positive, V_D is negative, or when V_S is negative, V_D is positive.

(2) When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.

5.13 +5 V / -8 V Dual Supply: Switching Characteristics

$V_{DD} = +5 V \pm 10\%$, $V_{SS} = -5 V \pm 10\%$, $GND = 0 V$ (unless otherwise noted)

Typical at $V_{DD} = +5 V$, $V_{SS} = -5 V$, $T_A = 25^\circ C$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
t_{TRAN}	Transition time from control input	$V_S = 3 V$ $R_L = 300 \Omega$, $C_L = 35 pF$ Refer to Transition Time	25°C		180	190	ns
			-40°C to +85°C		220		ns
			-40°C to +125°C		240		ns
$t_{ON (EN)}$	Turn-on time from enable	$V_S = 3 V$ $R_L = 300 \Omega$, $C_L = 35 pF$ Refer to Turn-on and Turn-off Time	25°C		120	180	ns
			-40°C to +85°C		215		ns
			-40°C to +125°C		240		ns
$t_{OFF (EN)}$	Turn-off time from enable	$V_S = 3 V$ $R_L = 300 \Omega$, $C_L = 35 pF$ Refer to Turn-on and Turn-off Time	25°C		130	220	ns
			-40°C to +85°C		245		ns
			-40°C to +125°C		270		ns
t_{BBM}	Break-before-make time delay	$V_S = 3 V$, $R_L = 300 \Omega$, $C_L = 35 pF$ Refer to Break-Before-Make	25°C		60		ns
			-40°C to +85°C		1		ns
			-40°C to +125°C		1		ns
$T_{ON (VDD)}$	Device turn on time (V_{DD} to output)	V_{DD} rise time = 1us $R_L = 300 \Omega$, $C_L = 35 pF$ Refer to Turn-on (VDD) Time	25°C		0.19		ms
			-40°C to +85°C		0.19	1	ms
			-40°C to +125°C		0.19	1	ms
t_{PD}	Propagation delay	$R_L = 50 \Omega$, $C_L = 5 pF$ Refer to Propagation Delay	25°C		650		ps
Q_{INJ}	Charge injection	$V_D = 0 V$, $C_L = 1 nF$ Refer to Charge Injection	25°C		14		pC
O_{ISO}	Off-isolation	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 0 V$, $f = 100$ kHz Refer to Off Isolation	25°C		-75		dB
O_{ISO}	Off-isolation	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 0 V$, $f = 1$ MHz Refer to Off Isolation	25°C		-55		dB
X_{TALK}	Crosstalk	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 0 V$, $f = 100$ kHz Refer to Crosstalk	25°C		-80		dB
X_{TALK}	Crosstalk	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 0 V$, $f = 1$ MHz Refer to Crosstalk	25°C		-70		dB
BW	-3dB Bandwidth	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 0 V$, Refer to Bandwidth	25°C		42		MHz
I_L	Insertion loss	$R_L = 50 \Omega$, $C_L = 5 pF$ $V_S = 0 V$, $f = 1$ MHz	25°C		-0.3		dB
$ACPSRR$	AC Power Supply Rejection Ratio	$V_{PP} = 0.62 V$ on V_{DD} and V_{SS} $R_L = 50 \Omega$, $C_L = 5 pF$, $f = 1$ MHz Refer to ACPSRR	25°C		-68		dB
$THD+N$	Total Harmonic Distortion + Noise	$V_{PP} = 5 V$, $V_{BIAS} = 0 V$ $R_L = 10 k\Omega$, $C_L = 5 pF$, $f = 20$ Hz to 20 kHz Refer to THD + Noise	25°C		0.001		%
$C_{S(OFF)}$	Source off capacitance	$V_S = 0 V$, $f = 1$ MHz	25°C		36		pF
$C_{D(OFF)}$	Drain off capacitance	$V_S = 0 V$, $f = 1$ MHz	25°C		53		pF
$C_{S(ON)}$, $C_{D(ON)}$	On capacitance	$V_S = 0 V$, $f = 1$ MHz	25°C		142		pF

5.14 ± 5 V Dual Supply: Electrical Characteristics

$V_{DD} = +5$ V $\pm 10\%$, $V_{SS} = -5$ V $\pm 10\%$, GND = 0 V (unless otherwise noted)

Typical at $V_{DD} = +5$ V, $V_{SS} = -5$ V, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R_{ON}	On-resistance	$V_{DD} = +4.5$ V, $V_{SS} = -4.5$ V $V_S = -4.5$ V to $+4.5$ V $I_D = -10$ mA Refer to On-Resistance	25°C	4	7.2	Ω	
			-40°C to +85°C		8.6	Ω	
			-40°C to +125°C		10	Ω	
ΔR_{ON}	On-resistance mismatch between channels	$V_S = -4.5$ V to $+4.5$ V $I_D = -10$ mA Refer to On-Resistance	25°C	0.1	0.3	Ω	
			-40°C to +85°C		0.35	Ω	
			-40°C to +125°C		0.4	Ω	
$R_{ON\,FLAT}$	On-resistance flatness	$V_S = -4.5$ V to $+4.5$ V $I_D = -10$ mA Refer to On-Resistance	25°C	1.3	2.2	Ω	
			-40°C to +85°C		2.5	Ω	
			-40°C to +125°C		2.8	Ω	
$R_{ON\,DRIFT}$	On-resistance drift	$V_S = 0$ V, $I_S = -10$ mA Refer to On-Resistance	-40°C to +125°C	0.019			$\Omega/\text{°C}$
$I_{S(OFF)}$	Source off leakage current ⁽¹⁾	$V_{DD} = +5.5$ V, $V_{SS} = -5.5$ V Switch state is off $V_S = +4.5$ V / -4.5 V $V_D = -4.5$ V / +4.5 V Refer to Off-Leakage Current	25°C	-0.3	0.05	0.3	nA
			-40°C to +85°C	-1		1	nA
			-40°C to +125°C	-30		30	nA
$I_{D(OFF)}$	Drain off leakage current ⁽¹⁾	$V_{DD} = +5.5$ V, $V_{SS} = -5.5$ V Switch state is off $V_S = +4.5$ V / -4.5 V $V_D = -4.5$ V / +4.5 V Refer to Off-Leakage Current	25°C	-0.4	0.05	0.4	nA
			-40°C to +85°C	-3		3	nA
			-40°C to +125°C	-50		50	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current ⁽²⁾	$V_{DD} = +5.5$ V, $V_{SS} = -5.5$ V Switch state is on $V_S = V_D = \pm 4.5$ V Refer to On-Leakage Current	25°C	-0.4	0.05	0.4	nA
			-40°C to +85°C	-3		3	nA
			-40°C to +125°C	-40		40	nA
LOGIC INPUTS (SEL / EN pins)							
V_{IH}	Logic voltage high		-40°C to +125°C	1.3	36	36	V
V_{IL}	Logic voltage low		-40°C to +125°C	0	0.8	0.8	V
I_{IH}	Input leakage current		-40°C to +125°C	0.005	2	2	μA
I_{IL}	Input leakage current		-40°C to +125°C	-1	-0.005		μA
C_{IN}	Logic input capacitance		-40°C to +125°C	3			pF
POWER SUPPLY							
I_{DD}	V_{DD} supply current	$V_{DD} = +5.5$ V, $V_{SS} = -5.5$ V Logic inputs = 0 V, 5 V, or V_{DD}	25°C	20	35	μA	
			-40°C to +85°C		40	μA	
			-40°C to +125°C		50	μA	
I_{SS}	V_{SS} supply current	$V_{DD} = +5.5$ V, $V_{SS} = -5.5$ V Logic inputs = 0 V, 5 V, or V_{DD}	25°C	0.001	5	μA	
			-40°C to +85°C		8	μA	
			-40°C to +125°C		15	μA	

(1) When V_S is positive, V_D is negative, or when V_S is negative, V_D is positive.

(2) When V_S is at a voltage potential, V_D is floating, or when V_D is at a voltage potential, V_S is floating.

5.15 ± 5 V Dual Supply: Switching Characteristics

$V_{DD} = +5 \text{ V} \pm 10\%$, $V_{SS} = -5 \text{ V} \pm 10\%$, $GND = 0 \text{ V}$ (unless otherwise noted)

Typical at $V_{DD} = +5 \text{ V}$, $V_{SS} = -5 \text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
t_{TRAN}	Transition time from control input	$V_S = 3 \text{ V}$ $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Transition Time	25°C		300	400	ns
			- 40°C to +85°C		490		ns
			- 40°C to +125°C		550		ns
$t_{ON \ (EN)}$	Turn-on time from enable	$V_S = 3 \text{ V}$ $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Turn-on and Turn-off Time	25°C		220	300	ns
			- 40°C to +85°C		350		ns
			- 40°C to +125°C		380		ns
$t_{OFF \ (EN)}$	Turn-off time from enable	$V_S = 3 \text{ V}$ $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Turn-on and Turn-off Time	25°C		210	280	ns
			- 40°C to +85°C		330		ns
			- 40°C to +125°C		350		ns
t_{BBM}	Break-before-make time delay	$V_S = 3 \text{ V}$, $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Break-Before-Make	25°C		50		ns
			- 40°C to +85°C		1		ns
			- 40°C to +125°C		1		ns
$T_{ON \ (VDD)}$	Device turn on time (V_{DD} to output)	V_{DD} rise time = 100 ns $R_L = 300 \Omega$, $C_L = 35 \text{ pF}$ Refer to Turn-on (VDD) Time	25°C		0.19		ms
			- 40°C to +85°C		0.19	1	ms
			- 40°C to +125°C		0.19	1	ms
t_{PD}	Propagation delay	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ Refer to Propagation Delay	25°C		650		ps
Q_{INJ}	Charge injection	$V_D = 0 \text{ V}$, $C_L = 1 \text{ nF}$ Refer to Charge Injection	25°C		- 5		pC
O_{ISO}	Off-isolation	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$, $f = 100 \text{ kHz}$ Refer to Off Isolation	25°C		- 75		dB
O_{ISO}	Off-isolation	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$ Refer to Off Isolation	25°C		- 55		dB
X_{TALK}	Crosstalk	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$, $f = 100 \text{ kHz}$ Refer to Crosstalk	25°C		- 117		dB
X_{TALK}	Crosstalk	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$ Refer to Crosstalk	25°C		- 106		dB
BW	- 3dB Bandwidth	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$, Refer to Bandwidth	25°C		43		MHz
I_L	Insertion loss	$R_L = 50 \Omega$, $C_L = 5 \text{ pF}$ $V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$	25°C		- 0.35		dB
$ACPSRR$	AC Power Supply Rejection Ratio	$V_{PP} = 0.62 \text{ V}$ on V_{DD} and V_{SS} $R_L = 50 \Omega$, $C_L = 5 \text{ pF}$, $f = 1 \text{ MHz}$ Refer to ACPSRR	25°C		- 68		dB
$THD+N$	Total Harmonic Distortion + Noise	$V_{PP} = 5 \text{ V}$, $V_{BIAS} = 0 \text{ V}$ $R_L = 10 \text{ k}\Omega$, $C_L = 5 \text{ pF}$, $f = 20 \text{ Hz}$ to 20 kHz Refer to THD + Noise	25°C		0.001		%
$C_{S(OFF)}$	Source off capacitance	$V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$	25°C		40		pF
$C_{D(OFF)}$	Drain off capacitance	$V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$	25°C		60		pF

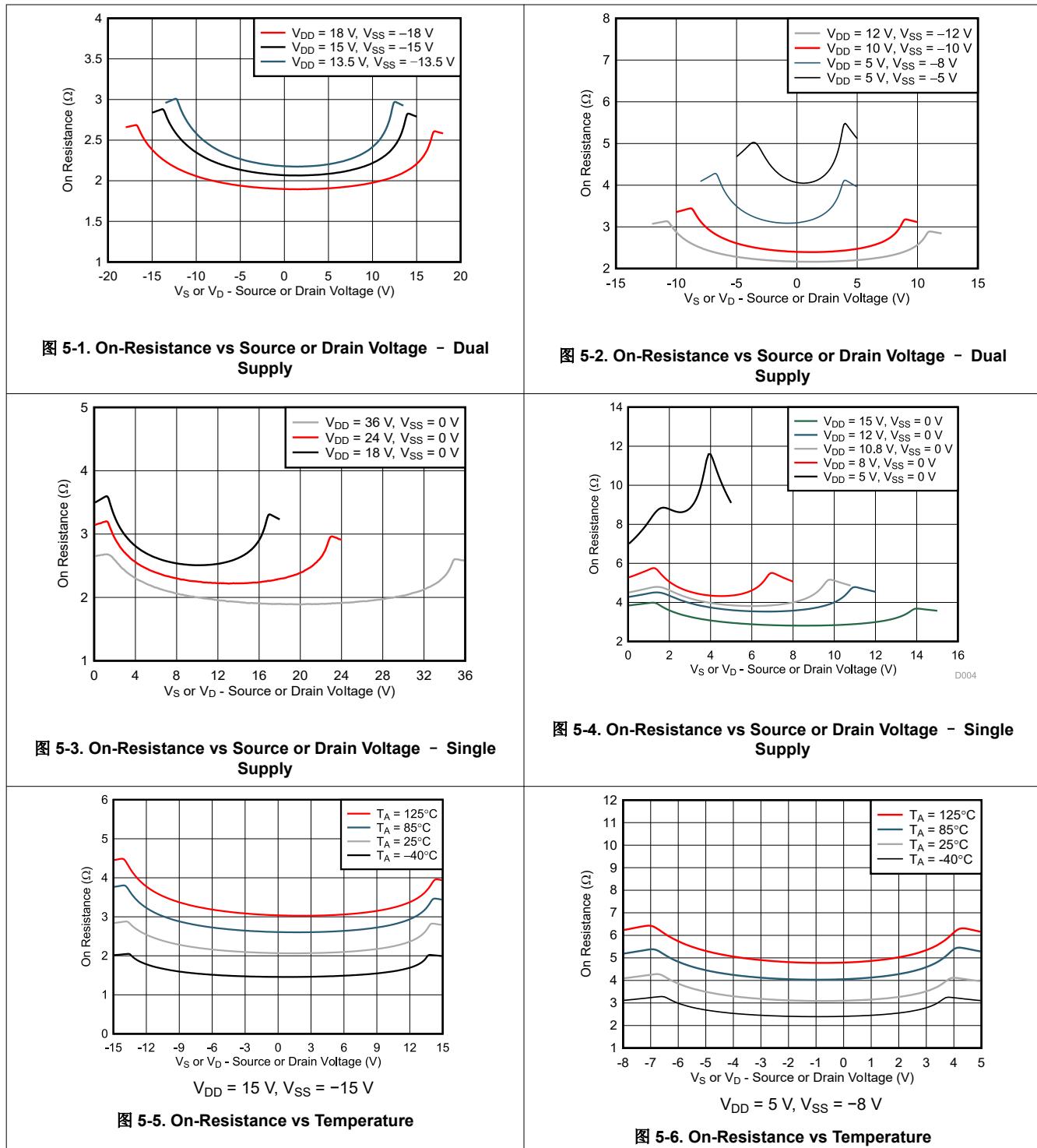
$V_{DD} = +5 \text{ V} \pm 10\%$, $V_{SS} = -5 \text{ V} \pm 10\%$, $\text{GND} = 0 \text{ V}$ (unless otherwise noted)

Typical at $V_{DD} = +5 \text{ V}$, $V_{SS} = -5 \text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
$C_{S(ON)}$, $C_{D(ON)}$	On capacitance $V_S = 0 \text{ V}$, $f = 1 \text{ MHz}$	25°C		150		pF

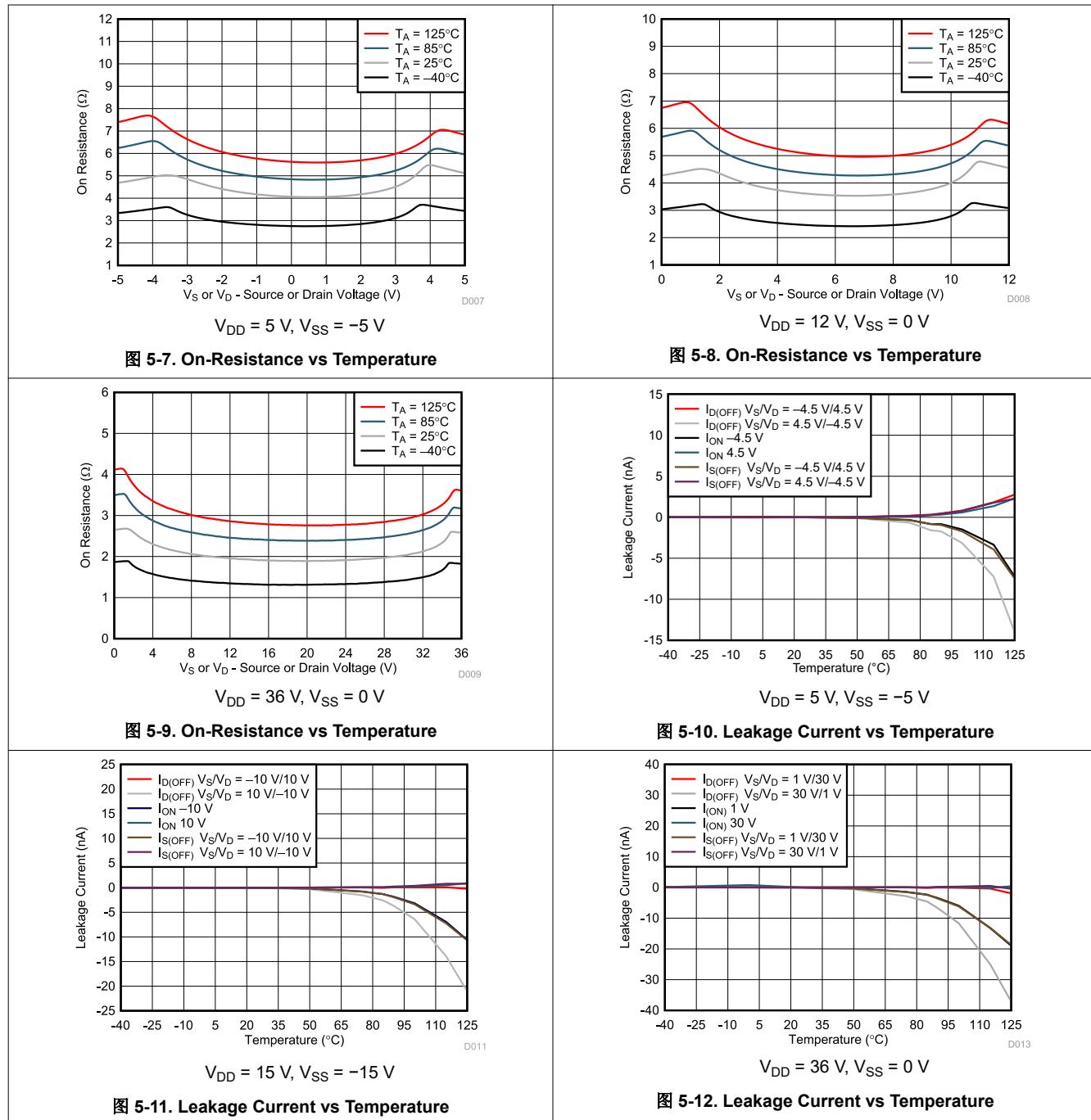
5.16 Typical Characteristics

at $T_A = 25^\circ\text{C}$



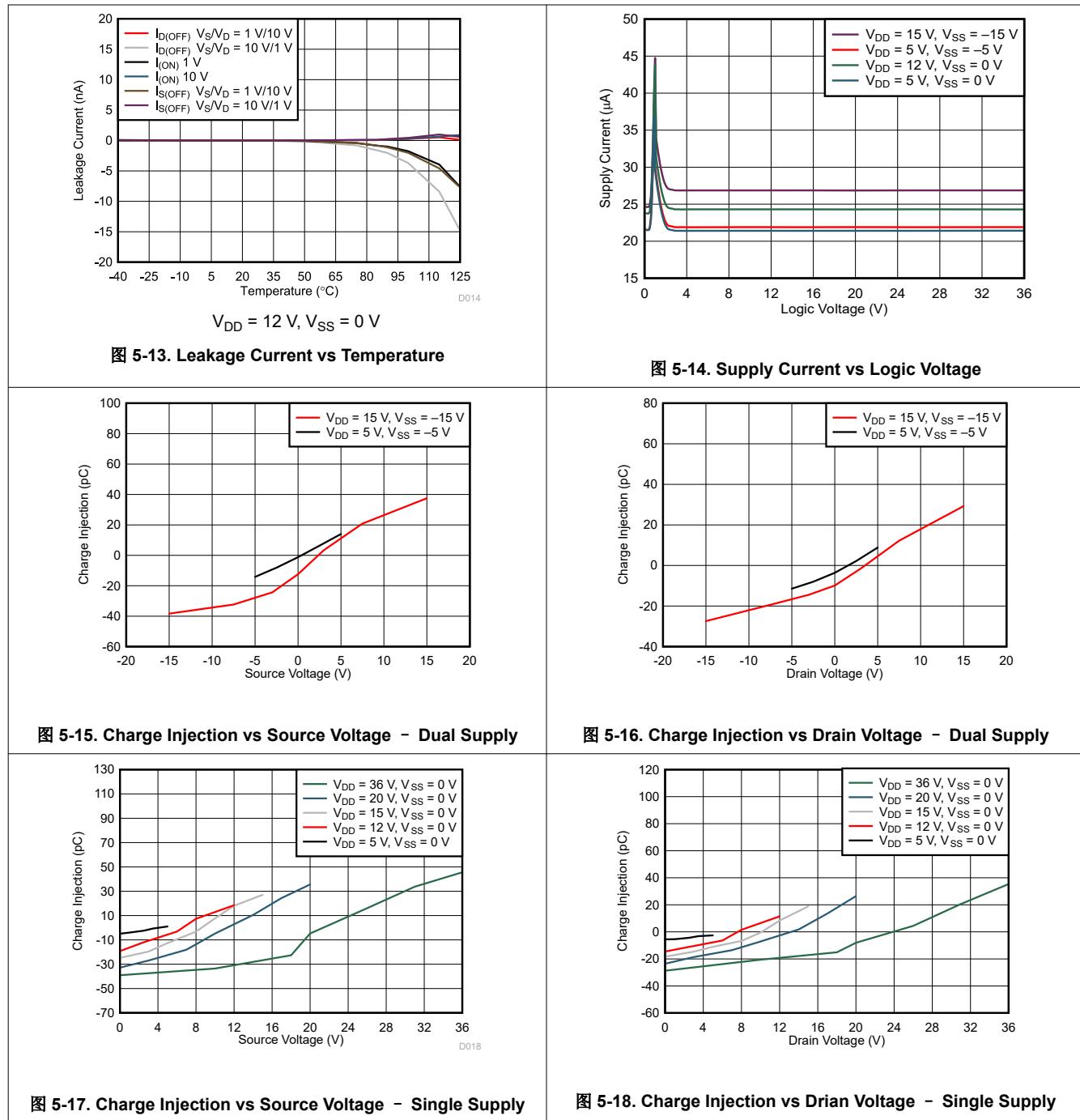
5.16 Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$



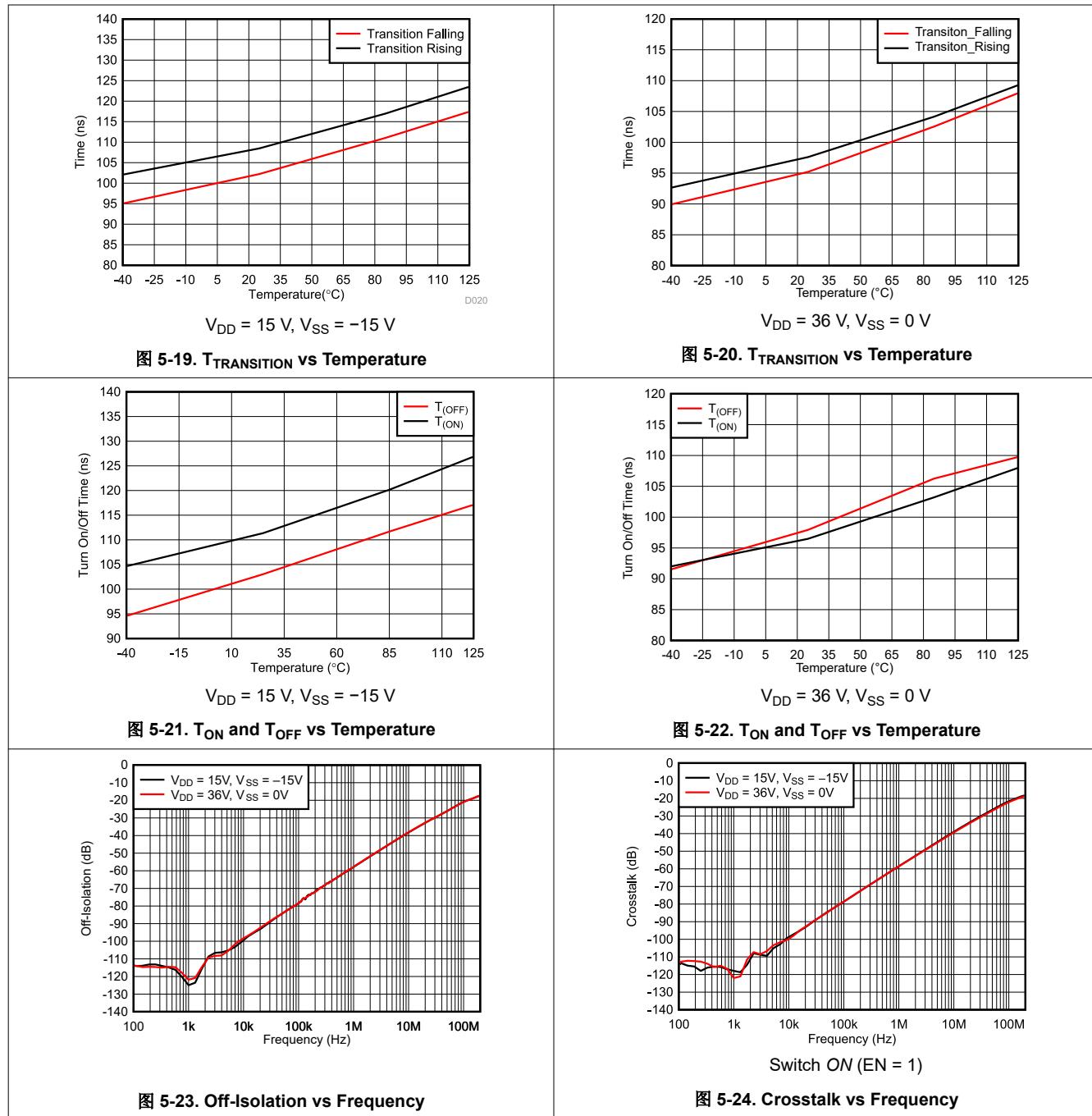
5.16 Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$



5.16 Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$



5.16 Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$

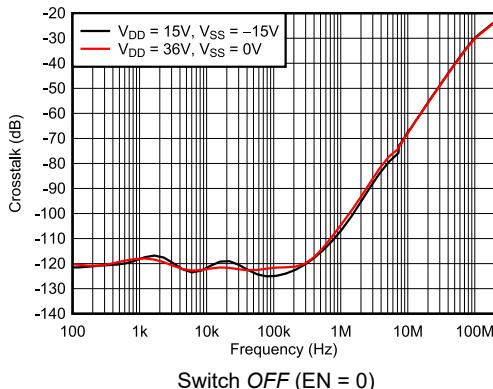


图 5-25. Crosstalk vs Frequency

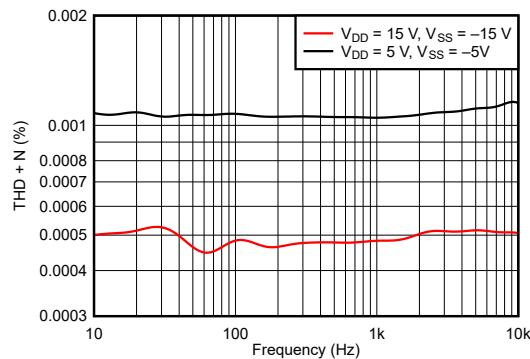


图 5-26. THD+N vs Frequency (Dual Supply)

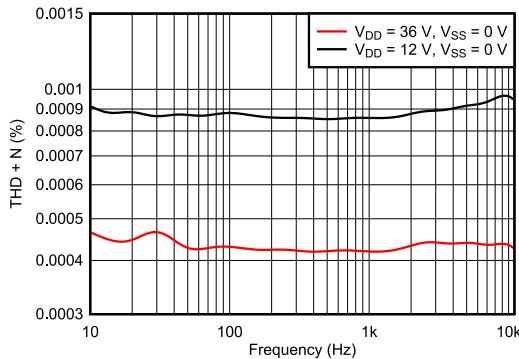
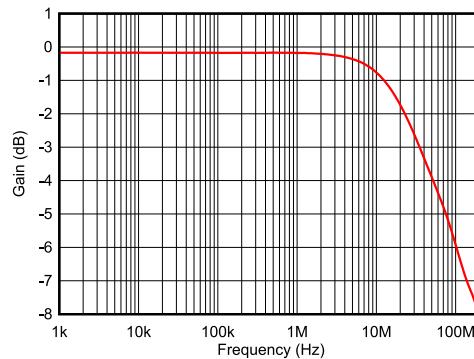
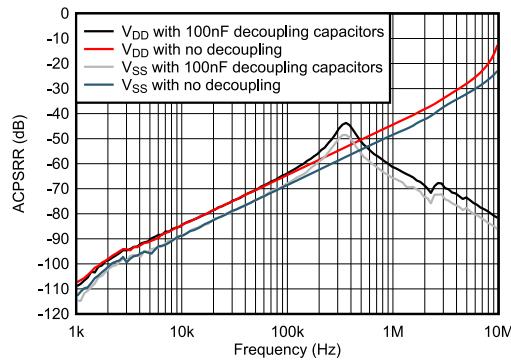


图 5-27. THD+N vs Frequency (Single Supply)



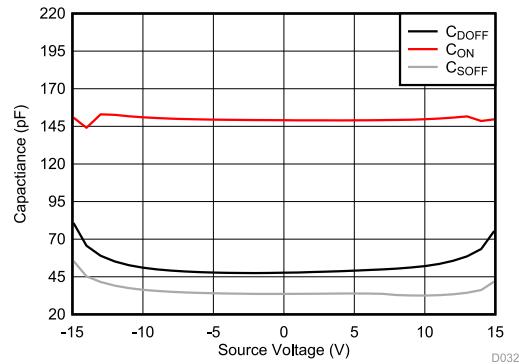
$V_{DD} = 15 \text{ V}, V_{SS} = -15 \text{ V}$

图 5-28. On Response vs Frequency



$V_{DD} = +15 \text{ V}, V_{SS} = -15 \text{ V}$

图 5-29. ACPSRR vs Frequency



$V_{DD} = +15 \text{ V}, V_{SS} = -15 \text{ V}$

图 5-30. Capacitance vs Source Voltage or Drain Voltage

5.16 Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$

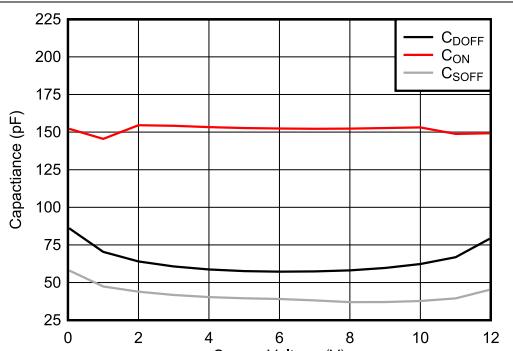


图 5-31. Capacitance vs Source Voltage or Drain Voltage

6 Parameter Measurement Information

6.1 On-Resistance

The on-resistance of a device is the ohmic resistance between the source (Sx) and drain (Dx) pins of the device. The on-resistance varies with input voltage and supply voltage. The symbol R_{ON} is used to denote on-resistance. [图 6-1](#) shows the measurement setup used to measure R_{ON} . Voltage (V) and current (I_{SD}) are measured using the following setup, where R_{ON} is computed as $R_{ON} = V / I_{SD}$:

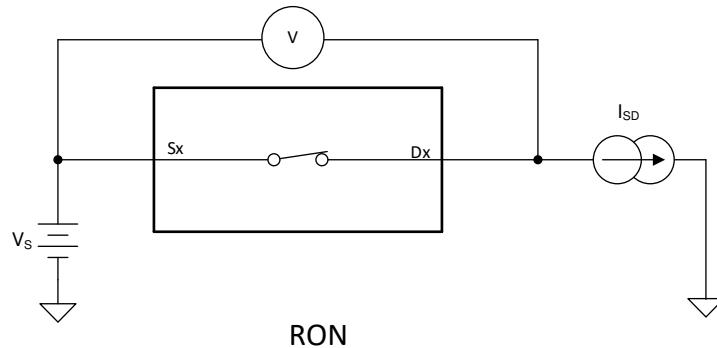


图 6-1. On-Resistance

6.2 Off-Leakage Current

There are two types of leakage currents associated with a switch during the off state:

1. Source off-leakage current.
2. Drain off-leakage current.

Source leakage current is defined as the leakage current flowing into or out of the source pin when the switch is off. This current is denoted by the symbol $I_{S(OFF)}$.

Drain leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is off. This current is denoted by the symbol $I_{D(OFF)}$.

[图 6-2](#) shows the setup used to measure both off-leakage currents.

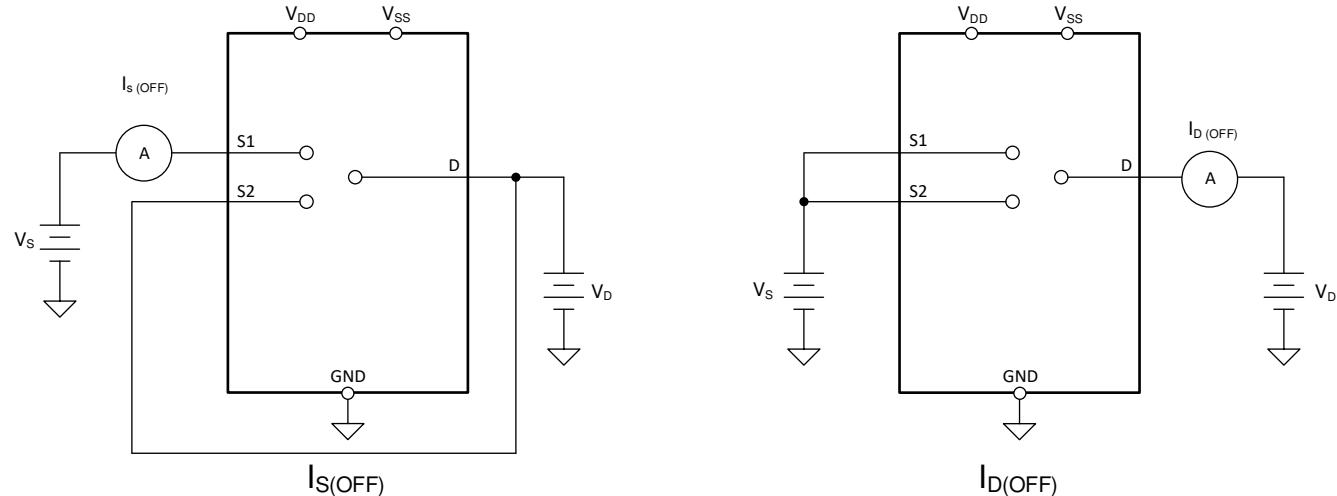


图 6-2. Off-Leakage Measurement Setup

6.3 On-Leakage Current

Source on-leakage current is defined as the leakage current flowing into or out of the source pin when the switch is on. This current is denoted by the symbol $I_{S(ON)}$.

Drain on-leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is on. This current is denoted by the symbol $I_{D(ON)}$.

Either the source pin or drain pin is left floating during the measurement. [图 6-3](#) shows the circuit used for measuring the on-leakage current, denoted by $I_{S(ON)}$ or $I_{D(ON)}$.

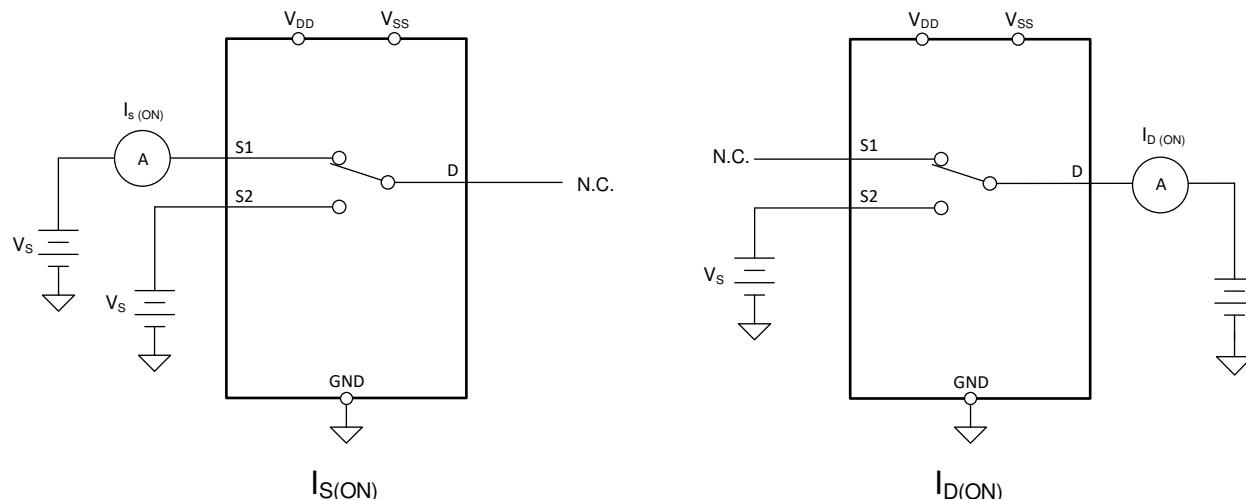


图 6-3. On-Leakage Measurement Setup

6.4 Transition Time

Transition time is defined as the time taken by the output of the device to rise or fall 90% after the address signal has risen or fallen past the logic threshold. The 90% transition measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. [图 6-4](#) shows the setup used to measure transition time, denoted by the symbol $t_{TRANSITION}$.

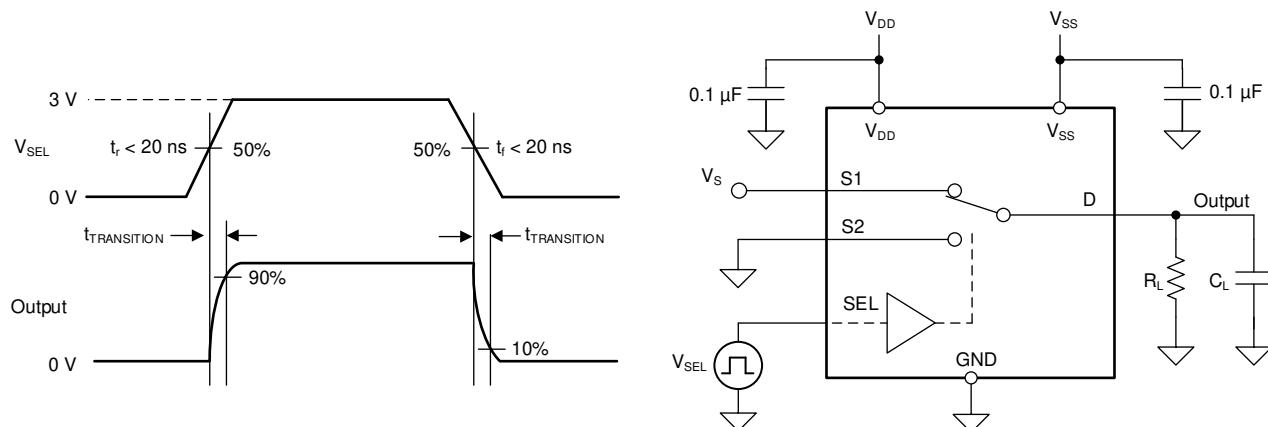


图 6-4. Transition-Time Measurement Setup

6.5 $t_{ON(EN)}$ and $t_{OFF(EN)}$

Turn-on time is defined as the time taken by the output of the device to rise to 90% after the enable has risen past the logic threshold. The 90% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. [图 6-5](#) shows the setup used to measure turn-on time, denoted by the symbol $t_{ON(EN)}$.

Turn-off time is defined as the time taken by the output of the device to fall to 10% after the enable has fallen past the logic threshold. The 10% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. [图 6-5](#) shows the setup used to measure turn-off time, denoted by the symbol $t_{OFF(EN)}$.

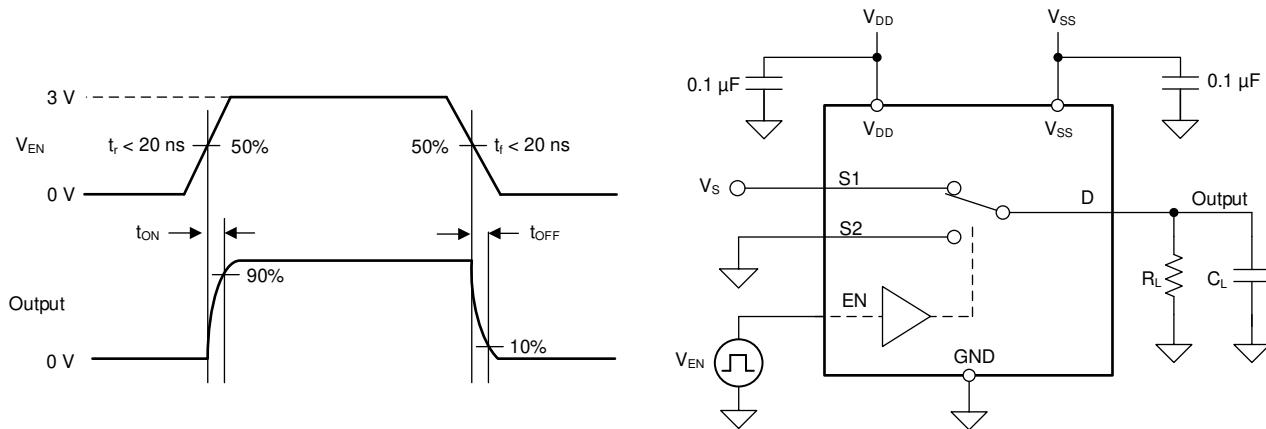


图 6-5. Turn-On and Turn-Off Time Measurement Setup

6.6 Break-Before-Make

Break-before-make delay is a safety feature that prevents two inputs from connecting when the device is switching. The output first breaks from the on-state switch before making the connection with the next on-state switch. The time delay between the *break* and the *make* is known as break-before-make delay. [图 6-6](#) shows the setup used to measure break-before-make delay, denoted by the symbol $t_{OPEN(BBM)}$.

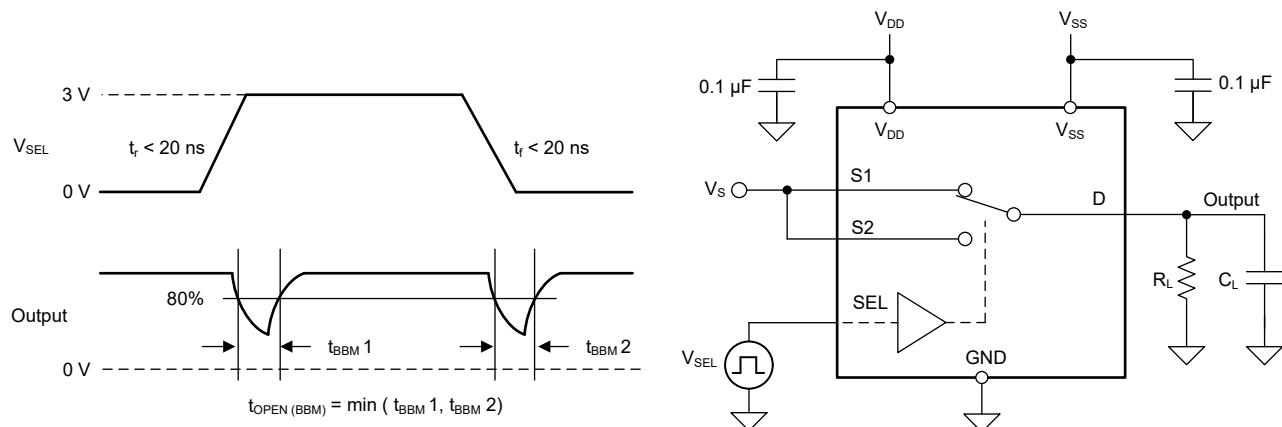


图 6-6. Break-Before-Make Delay Measurement Setup

6.7 $t_{ON(VDD)}$ Time

The $t_{ON(VDD)}$ time is defined as the time taken by the output of the device to rise to 90% after the supply has risen past the supply threshold. The 90% measurement is used to provide the timing of the device turning on in the system. [图 6-7](#) shows the setup used to measure turn on time, denoted by the symbol $t_{ON(VDD)}$.

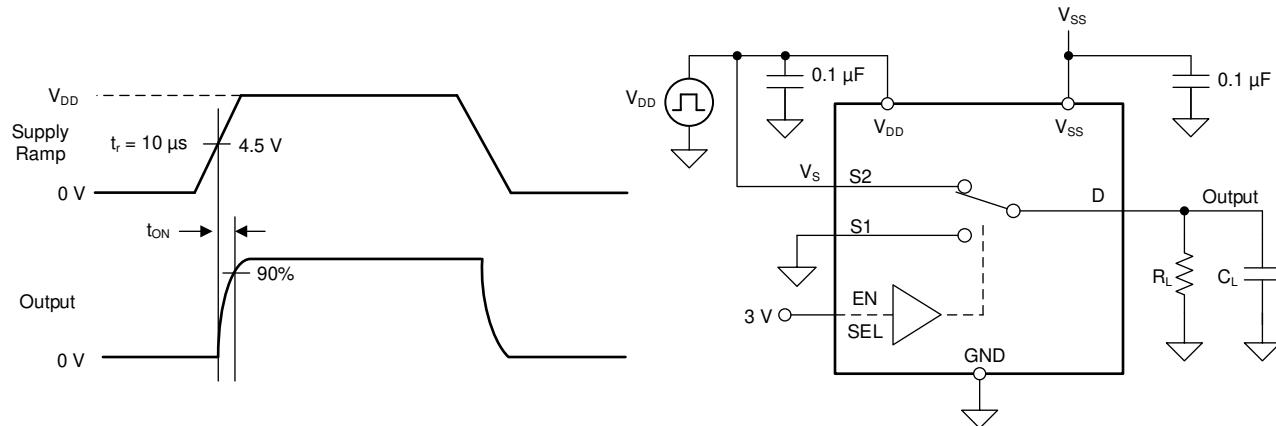


图 6-7. $t_{ON(VDD)}$ Time Measurement Setup

6.8 Propagation Delay

Propagation delay is defined as the time taken by the output of the device to rise or fall 50% after the input signal has risen or fallen past the 50% threshold. [图 6-8](#) shows the setup used to measure propagation delay, denoted by the symbol t_{PD} .

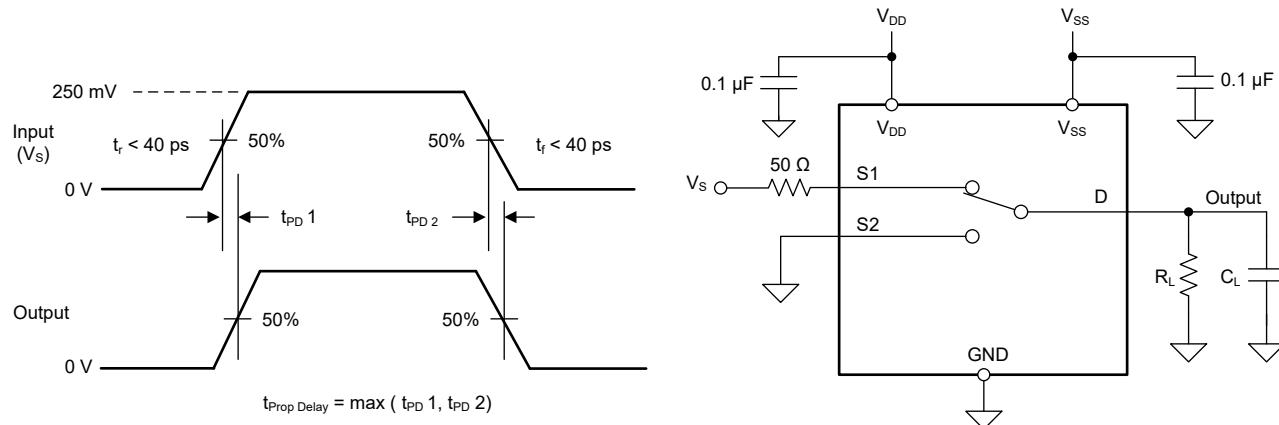


图 6-8. Propagation Delay Measurement Setup

6.9 Charge Injection

The TMUX6219 has a transmission-gate topology. Any mismatch in capacitance between the NMOS and PMOS transistors results in a charge injected into the drain or source during the falling or rising edge of the gate signal. The amount of charge injected into the source or drain of the device is known as charge injection, and is denoted by the symbol Q_C . [图 6-9](#) shows the setup used to measure charge injection from source (Sx) to drain (D).

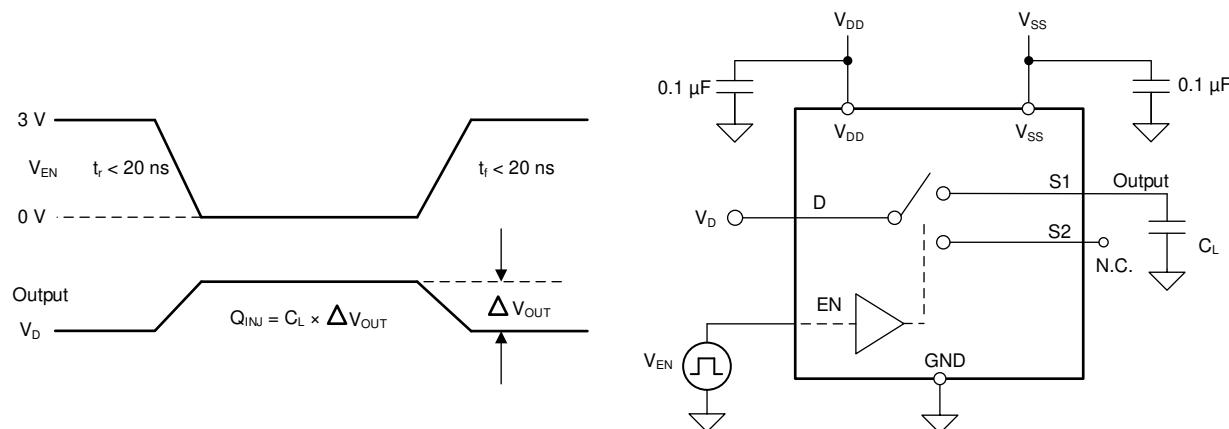
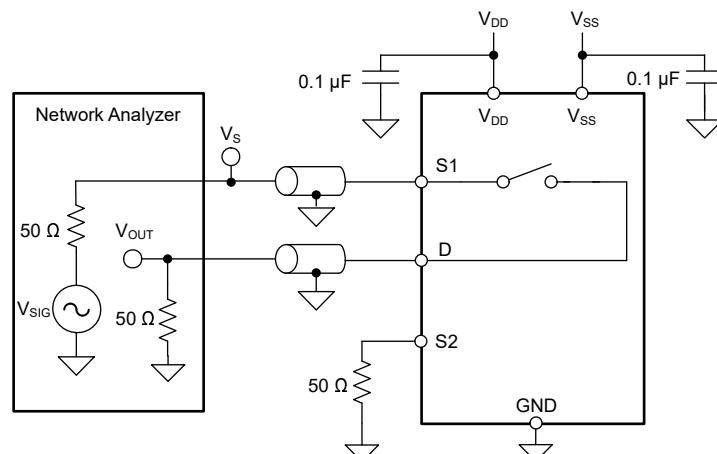


图 6-9. Charge-Injection Measurement Setup

6.10 Off Isolation

Off isolation is defined as the ratio of the signal at the drain pin (D) of the device when a signal is applied to the source pin (Sx) of an off-channel. [图 6-10](#) shows the setup used to measure, and the equation used to calculate off isolation.



$$\text{Off Isolation} = 20 \times \log \frac{V_{\text{OUT}}}{V_s}$$

图 6-10. Off Isolation Measurement Setup

6.11 Crosstalk

Crosstalk is defined as the ratio of the signal at the drain pin (D) of a different channel, when a signal is applied at the source pin (Sx) of an on-channel. [图 6-11](#) shows the setup used to measure, and the equation used to calculate crosstalk.

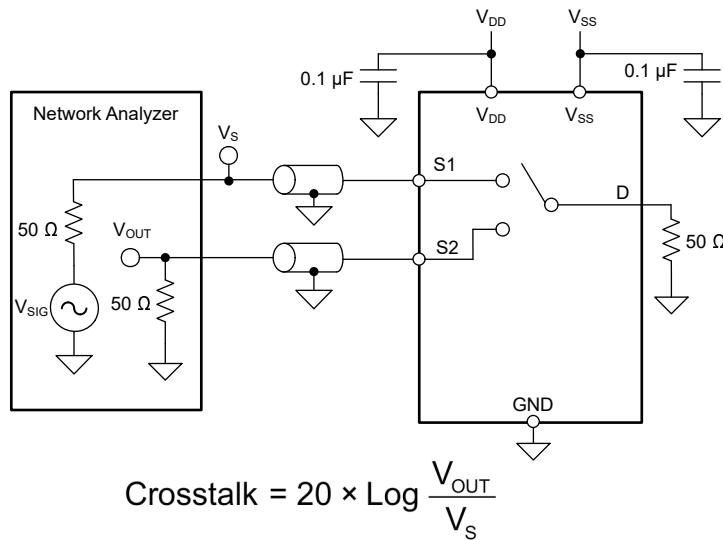


图 6-11. Crosstalk Measurement Setup

6.12 Bandwidth

Bandwidth is defined as the range of frequencies that are attenuated by less than 3 dB when the input is applied to the source pin (Sx) of an on-channel, and the output is measured at the drain pin (D) of the device. [图 6-12](#) shows the setup used to measure bandwidth.

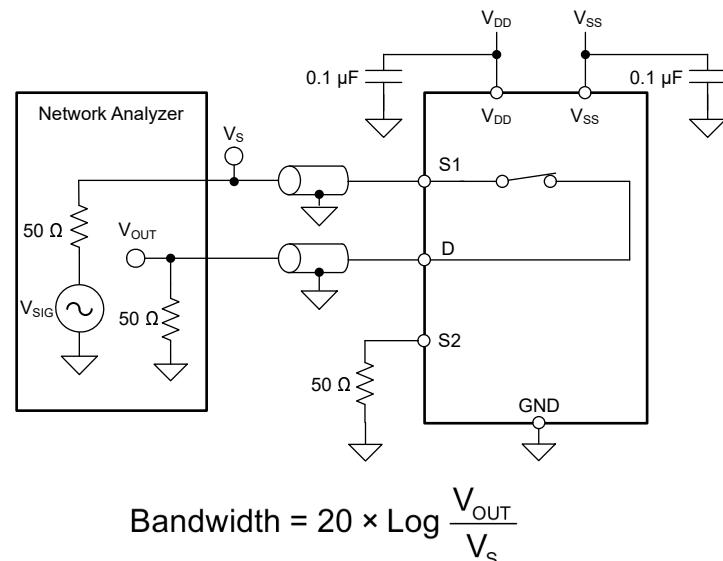


图 6-12. Bandwidth Measurement Setup

6.13 THD + Noise

The total harmonic distortion (THD) of a signal is a measurement of the harmonic distortion, and is defined as the ratio of the sum of the powers of all harmonic components to the power of the fundamental frequency at the mux output.

The on-resistance of the device varies with the amplitude of the input signal and results in distortion when the drain pin is connected to a low-impedance load. Total harmonic distortion plus noise is denoted as THD + N.

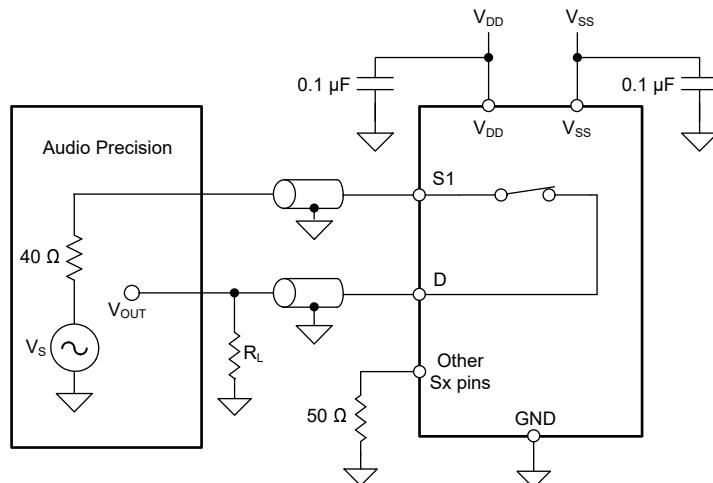
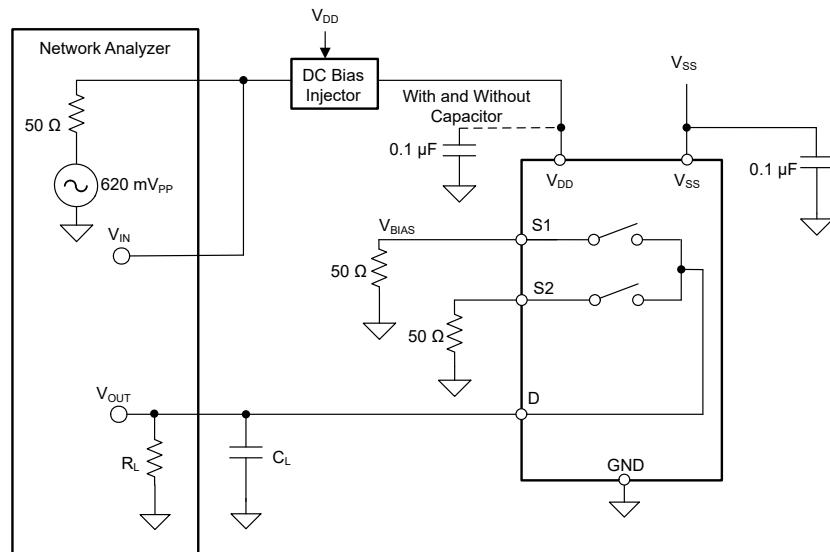


图 6-13. THD + N Measurement Setup

6.14 Power Supply Rejection Ratio (PSRR)

PSRR measures the ability of a device to prevent noise and spurious signals that appear on the supply voltage pin from coupling to the output of the switch. The DC voltage on the device supply is modulated by a sine wave of 620 mV_{PP}. The ratio of the amplitude of signal on the output to the amplitude of the modulated signal is the ACPSRR. A high ratio represents a high degree of tolerance to supply rail variation.

This helps stabilize the supply and immediately filter as much of the supply noise as possible.



$$PSRR = 20 \times \log \frac{V_{\text{OUT}}}{V_{\text{IN}}}$$

图 6-14. ACPSRR Measurement Setup

7 Detailed Description

7.1 Overview

The TMUX6219 is a 2:1, 1-channel switch. Each input is turned on or turned off based on the state of the select line and enable pin.

7.2 Functional Block Diagram

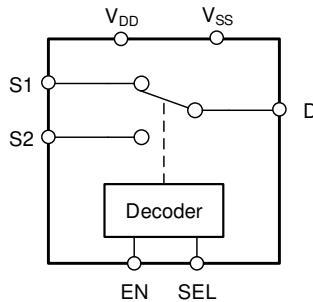


图 7-1. TMUX6219 Functional Block Diagram

7.3 Feature Description

7.3.1 Bidirectional Operation

The TMUX6219 conducts equally well from source (Sx) to drain (D) or from drain (D) to source (Sx). Each channel has very similar characteristics in both directions and supports both analog and digital signals.

7.3.2 Rail to Rail Operation

The valid signal path input or output voltage for TMUX6219 ranges from V_{SS} to V_{DD}.

7.3.3 1.8V Logic Compatible Inputs

The TMUX6219 has 1.8-V logic compatible control for all logic control inputs. 1.8-V logic level inputs allows the TMUX6219 to interface with processors that have lower logic I/O rails and eliminates the need for an external translator, which saves both space and BOM cost. For more information on 1.8V logic implementations refer to [Simplifying Design with 1.8V logic Muxes and Switches](#).

7.3.4 Fail-Safe Logic

The TMUX6219 supports Fail-Safe Logic on the control input pins (EN and SEL) allowing for operation up to 36V above ground, regardless of the state of the supply pins. This feature allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage. Fail-Safe Logic minimizes system complexity by removing the need for power supply sequencing on the logic control pins. For example, the Fail-Safe Logic feature allows the logic input pins of the TMUX6219 to be ramped to +36V while V_{DD} and V_{SS} = 0V. The logic control inputs are protected against positive faults of up to +36V in powered-off condition, but do not offer protection against negative overvoltage conditions.

7.3.5 Latch-Up Immune

Latch-up is a condition where a low impedance path is created between a supply pin and ground. This condition is caused by a trigger (current injection or overvoltage), but once activated, the low impedance path remains even after the trigger is no longer present. This low impedance path may cause system upset or catastrophic damage due to excessive current levels. The latch-up condition typically requires a power cycle to eliminate the low impedance path.

The TMUX62xx family of devices are constructed on Silicon on Insulator (SOI) based process where an oxide layer is added between the PMOS and NMOS transistor of each CMOS switch to prevent parasitic structures from forming. The oxide layer is also known as an insulating trench and prevents triggering of latch up events due to overvoltage or current injections. The latch-up immunity feature allows the TMUX62xx family of switches and multiplexers to be used in harsh environments.

7.3.6 Ultra-Low Charge Injection

The TMUX6219 has a transmission gate topology, as shown in [图 7-2](#). Any mismatch in the stray capacitance associated with the NMOS and PMOS causes an output level change whenever the switch is opened or closed.

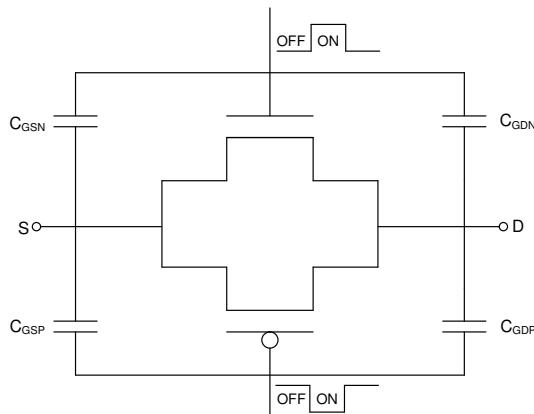


图 7-2. Transmission Gate Topology

The TMUX6219 contains specialized architecture to reduce charge injection on the source (Sx). To further reduce charge injection in a sensitive application, a compensation capacitor (Cp) can be added on the drain (D). This will ensure that excess charge from the switch transition will be pushed into the compensation capacitor on the drain (D) instead of the source (Sx). As a general rule, Cp should be 20× larger than the equivalent load capacitance on the source (Sx). [图 7-3](#) shows charge injection variation with source voltage with different compensation capacitors on the Drain side.

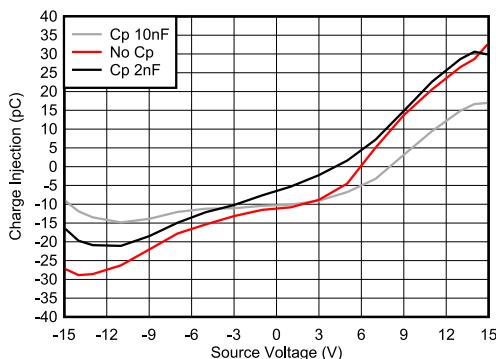


图 7-3. Charge Injection Compensation

7.4 Device Functional Modes

When the EN pin of the TMUX6219 is pulled high, one of the switches is closed based on the state of the SEL pin. When the EN pin is pulled low, both of the switches are in an open state regardless of the state of the SEL pin. The control pins can be as high as 36V.

The TMUX6219 can be operated without any external components except for the supply decoupling capacitors. The EN pin has an internal pull-up resistor of $4\text{ M}\Omega$ and SEL pin has internal pull-down resistor of $4\text{ M}\Omega$. If unused, the EN pin must be tied to V_{DD} and SEL pin must be tied to GND to ensure the device does not consume additional current as highlighted in [Implications of Slow or Floating CMOS Inputs](#). Unused signal path inputs (S1, S2, or D) should be connected to GND.

7.5 Truth Tables

表 7-1 provides the truth tables for the TMUX6219.

表 7-1. TMUX6219 Truth Table

EN	SEL	Selected Source Connected To Drain (D) Pin
0	X ⁽¹⁾	All sources are off (HI-Z)
1	0	S1
1	1	S2

(1) X denotes *do not care*.

8 Application and Implementation

备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

8.1 Application Information

TMUX6219 is part of the precision switches and multiplexers family of devices. TMUX6219 offers low RON, low on and off leakage currents and ultra-low charge injection performance. These properties make TMUX6219 ideal for implementing high precision industrial systems requiring selection of one of two inputs or outputs.

8.2 Typical Application

8.2.1 Power Amplifier Gate Driver

One application of the TMUX6219 is for input control of a power amplifier gate driver. Utilizing a switch allows a system to control when the DAC is connected to the power amplifier and can stop biasing the power amplifier by switching the gate to V_{SS} . The wide dual supply range of $\pm 4.5V$ to $\pm 18V$ allows the switch to work with GaN power amplifiers, and the wide single supply range 4.5V to 36V works well with LDMOS power amplifiers.

图 8-1 shows the TMUX6219 configured for control of the power amplifier gate driver in GaN application.

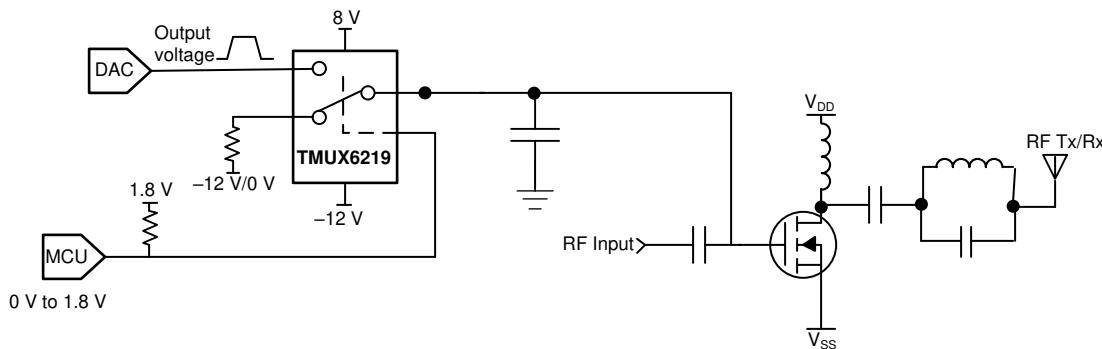


图 8-1. Power Amplifier Gate Driver

8.2.2 Design Requirements

For the design example, use the parameters listed in 表 8-1.

表 8-1. Design Parameters

PARAMETERS	VALUES	
	GAN application	LDMOS application
Supply (V_{DD})	8V	5V
Supply (V_{SS})	-12V	0V
MUX I/O signal range	-12V to 8V (Rail-to-Rail)	0V to 5V (Rail-to-Rail)
Control logic thresholds	1.8V compatible (up to V_{DD})	1.8V compatible (up to V_{DD})
EN	EN pulled high to enable the switch	EN pulled high to enable the switch

8.2.3 Detailed Design Procedure

The application shown in [图 8-1](#) demonstrates how to toggle between the DAC output and low signal voltage for control of a GaN power amplifier using a single control input. The DAC output is utilized to bias the gate of the power amplifier and can be disconnected from the circuit using the select pin of the switch. The TMUX6219 can support 1.8V logic signals on the control input, allowing the device to interface with low logic controls of an FPGA or MCU. The TMUX6219 can operate without any external components except for the supply decoupling capacitors. The select pin has an internal pull-down resistor to prevent floating input logic. All inputs to the switch must fall within the recommended operating conditions of the TMUX6219 including signal range and continuous current. For this design with a positive supply of 8V on V_{DD} and negative supply of -12V on V_{SS} , the signal range can be 8V to -12V. The maximum continuous current (I_{DC}) can be up to 330mA as shown in the *Recommended Operating Conditions table* for wide-range current measurement.

8.2.4 Application Curve

The low on and off leakage currents of TMUX6219 and ultra-low charge injection performance make this device ideal for implementing high precision industrial systems. [图 8-2](#) shows the plot for the charge injection versus source voltage for the TMUX6219.

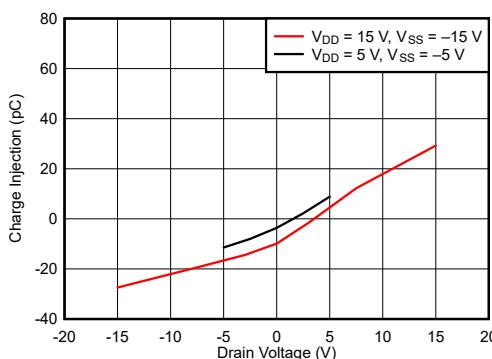


图 8-2. Charge Injection vs Drain Voltage

9 Power Supply Recommendations

The TMUX6219 operates across a wide supply range of $\pm 4.5V$ to $\pm 18V$ (4.5V to 36V in single-supply mode). As shown in [图 8-1](#), the device also performs well with asymmetrical supplies such as $V_{DD} = 5V$ and $V_{SS} = -8V$.

Power-supply bypassing improves noise margin and prevents switching noise propagation from the supply rails to other components. Good power-supply decoupling is important to achieve optimum performance. For improved supply noise immunity, use a supply decoupling capacitor ranging from $0.1 \mu F$ to $10 \mu F$ at both the V_{DD} and V_{SS} pins to ground. Place the bypass capacitors as close to the power supply pins of the device as possible using low-impedance connections. TI recommends using multi-layer ceramic chip capacitors (MLCCs) that offer low equivalent series resistance (ESR) and inductance (ESL) characteristics for power-supply decoupling purposes. For very sensitive systems, or for systems in harsh noise environments, avoiding the use of vias for connecting the capacitors to the device pins may offer superior noise immunity. The use of multiple vias in parallel lowers the overall inductance and is beneficial for connections to power and ground planes. Always ensure the ground (GND) connection is established before supplies are ramped.

10 Layout

10.1 Layout Guidelines

When a PCB trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners. [图 10-1](#) shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.

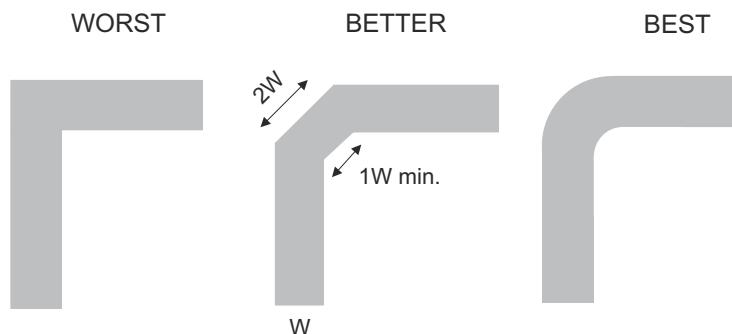


图 10-1. Trace Example

Route high-speed signals using a minimum of vias and corners which reduces signal reflections and impedance changes. When a via must be used, increase the clearance size around it to minimize its capacitance. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points, through-hole pins are not recommended at high frequencies.

[图 10-2](#) shows an example of a PCB layout with the TMUX6219. Some key considerations are as follows:

- Decouple the supply pins with a $0.1\mu\text{F}$ and $1\mu\text{F}$ capacitor, and place the lowest value capacitor as close to the pin as possible. Make sure that the capacitor voltage rating is sufficient for the supply voltage.
- Keep the input lines as short as possible.
- Use a solid ground plane to help reduce electromagnetic interference (EMI) noise pickup.
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when necessary.
- Using multiple vias in parallel will lower the overall inductance and is beneficial for connection to ground planes.

10.2 Layout Example

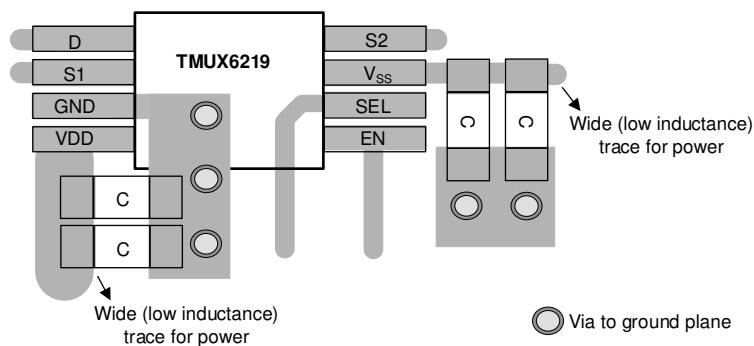


图 10-2. TMUX6219 DGK Layout Example

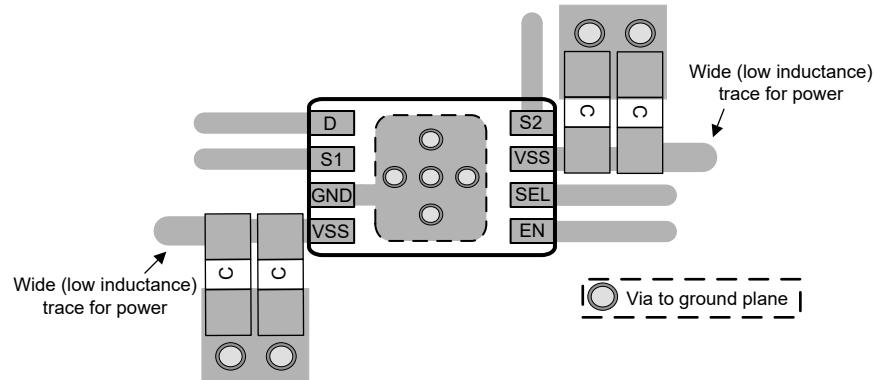


图 10-3. TMUX6219 RQX Layout Example

11 Device and Documentation Support

11.1 Documentation Support

11.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, *Improve Stability Issues with Low CON Multiplexers* application brief
- Texas Instruments, *Improving Signal Measurement Accuracy in Automated Test Equipment* application brief
- Texas Instruments, *Multiplexers and Signal Switches Glossary* application report
- Texas Instruments, *QFN/SON PCB Attachment* application report
- Texas Instruments, *Quad Flatpack No-Lead Logic Packages* application report
- Texas Instruments, *Simplifying Design with 1.8V logic Muxes and Switches* application brief
- Texas Instruments, *System-Level Protection for High-Voltage Analog Multiplexers* application report
- Texas Instruments, *True Differential, 4 x 2 MUX, Analog Front End, Simultaneous-Sampling ADC Circuit* application report

11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.3 支持资源

[TI E2E™ 中文支持论坛](#)是工程师的重要参考资料，可直接从专家处获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题，获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的[使用条款](#)。

11.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

所有商标均为其各自所有者的财产。

11.5 静电放电警告



静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

11.6 术语表

TI 术语表

本术语表列出并解释了术语、首字母缩略词和定义。

12 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision D (July 2022) to Revision E (July 2024)	Page
• Changed IIH max specification.....	6

Changes from Revision C (June 2022) to Revision D (July 2022)	Page
• 将 RQX 封装状态从 预发布 更改为 正在供货	1
• Added +5 V / -8 V electrical and switching characteristics tables.....	15

Changes from Revision B (January 2021) to Revision C (June 2022)	Page
• Added the RQX package details to the <i>Pin Configuration and Functions</i> section.....	3

Changes from Revision A (October 2020) to Revision B (January 2021)	Page
• 将文档状态从预告信息 更改为量产数据	1

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TMUX6219DGKR	Active	Production	VSSOP (DGK) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	X219
TMUX6219DGKR.B	Active	Production	VSSOP (DGK) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	X219
TMUX6219DGKRG4	Active	Production	VSSOP (DGK) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	X219
TMUX6219DGKRG4.B	Active	Production	VSSOP (DGK) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	X219
TMUX6219RQXR	Active	Production	WSON (RQX) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	H219
TMUX6219RQXR.B	Active	Production	WSON (RQX) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	H219

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

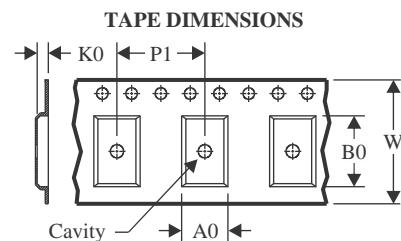
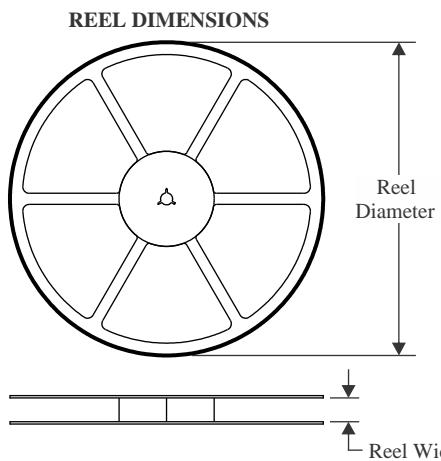
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF TMUX6219 :

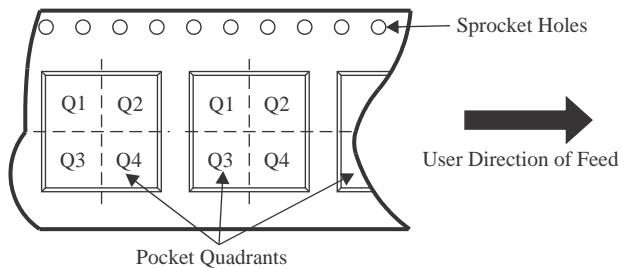
- Automotive : [TMUX6219-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

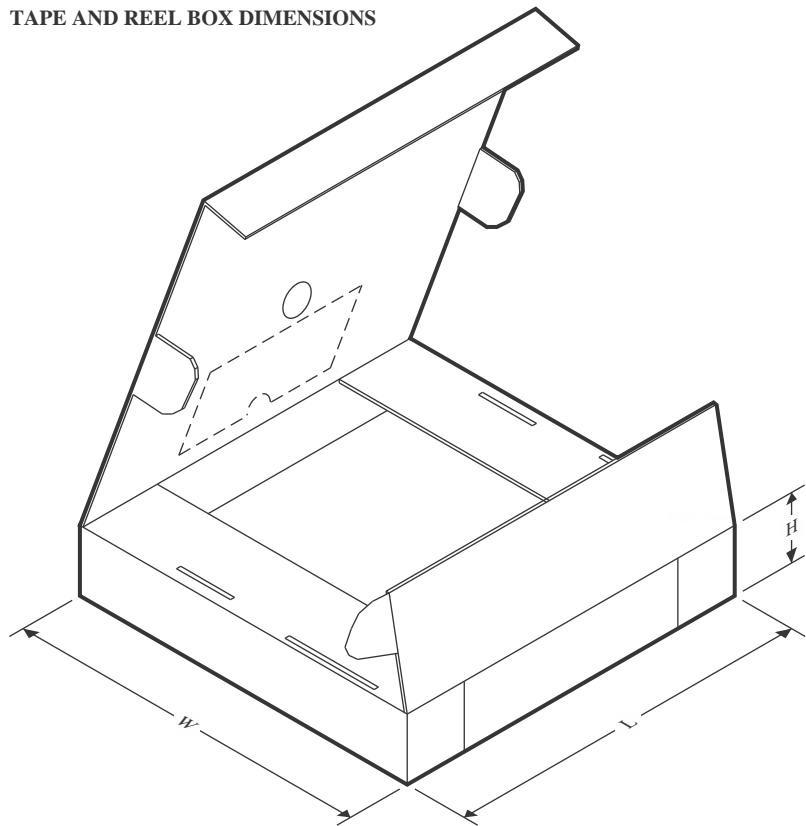
TAPE AND REEL INFORMATION


A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMUX6219DGKR	VSSOP	DGK	8	2500	330.0	12.4	5.25	3.35	1.25	8.0	12.0	Q1
TMUX6219DGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
TMUX6219DGKRG4	VSSOP	DGK	8	2500	330.0	12.4	5.25	3.35	1.25	8.0	12.0	Q1
TMUX6219RQXR	WSO	RQX	8	2500	178.0	13.5	2.2	3.2	1.1	4.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TMUX6219DGKR	VSSOP	DGK	8	2500	366.0	364.0	50.0
TMUX6219DGKR	VSSOP	DGK	8	2500	353.0	353.0	32.0
TMUX6219DGKRG4	VSSOP	DGK	8	2500	366.0	364.0	50.0
TMUX6219RQXR	WSON	RQX	8	2500	189.0	185.0	36.0

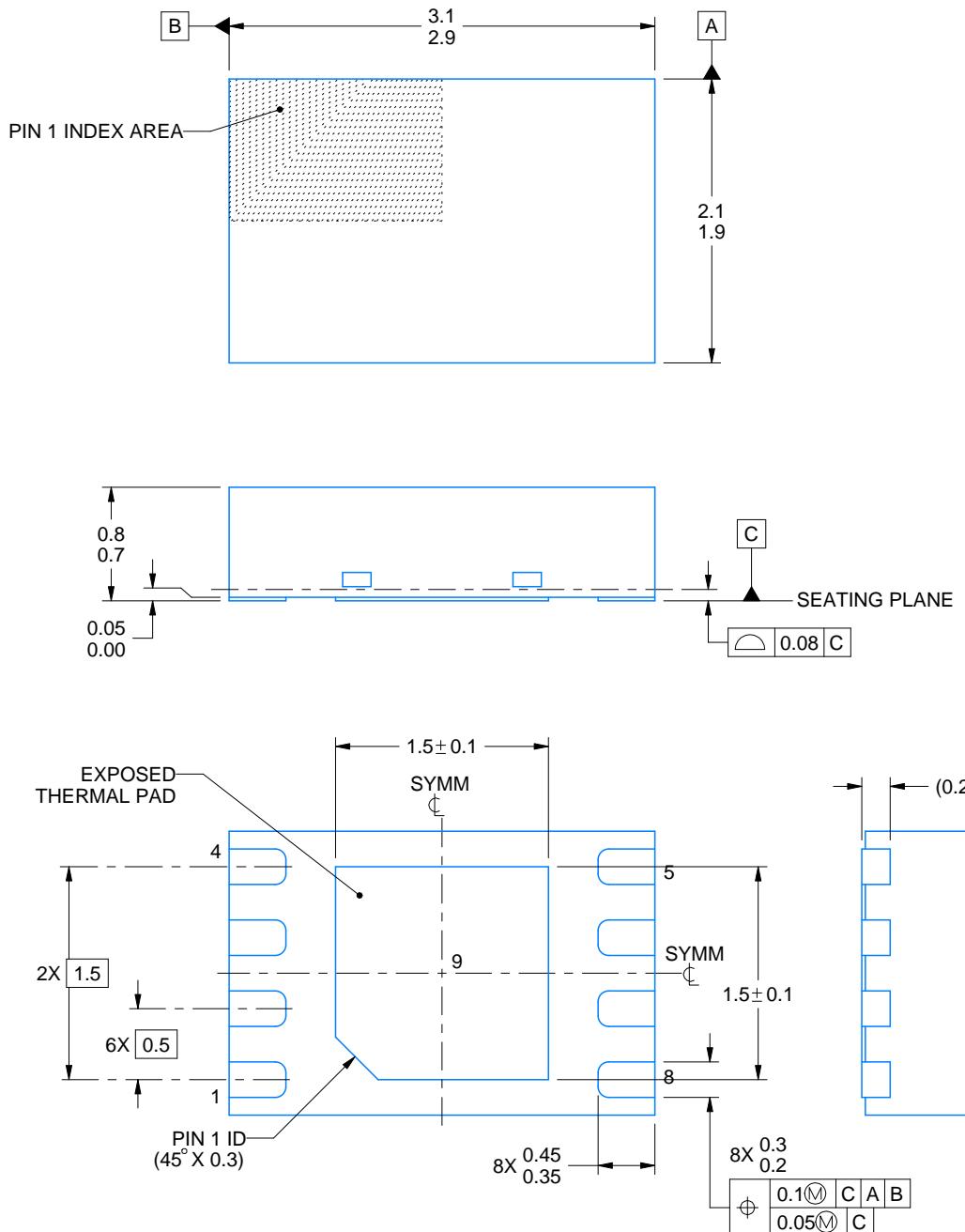
PACKAGE OUTLINE

RQX0008B



WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



4232251/A 09/2025

NOTES:

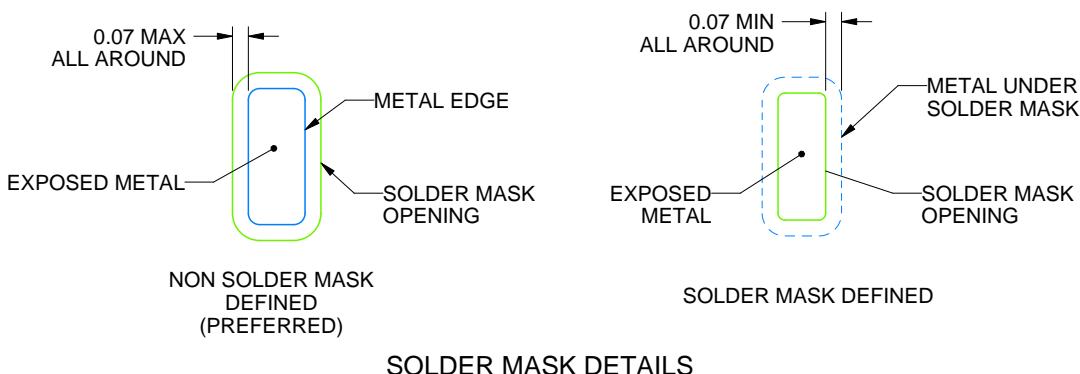
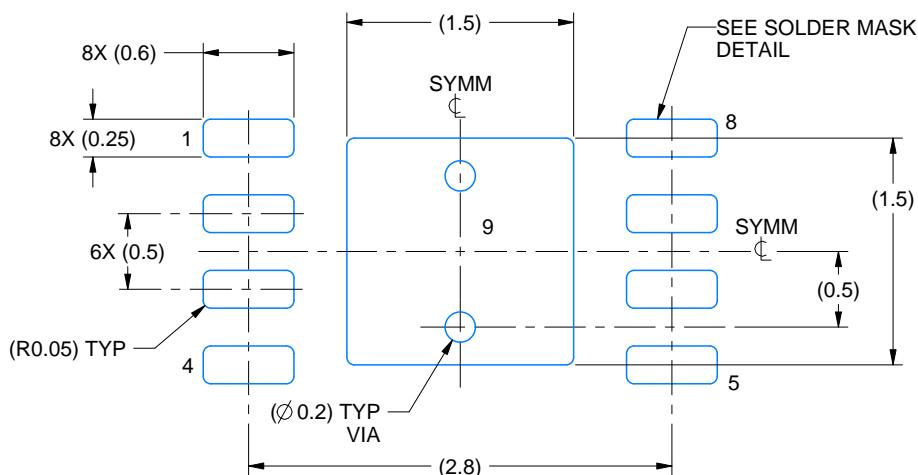
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

RQX0008B

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



4232251/A 09/2025

NOTES: (continued)

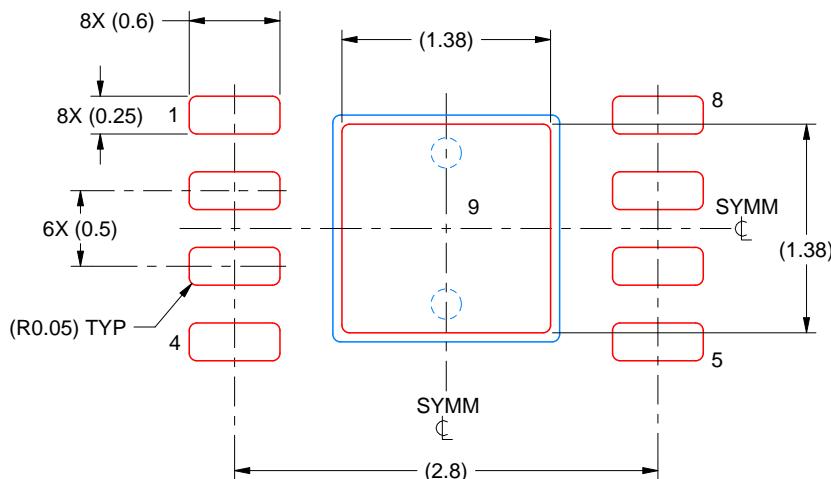
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

RQX0008B

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 20X

EXPOSED PAD 9
85% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

4232251/A 09/2025

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

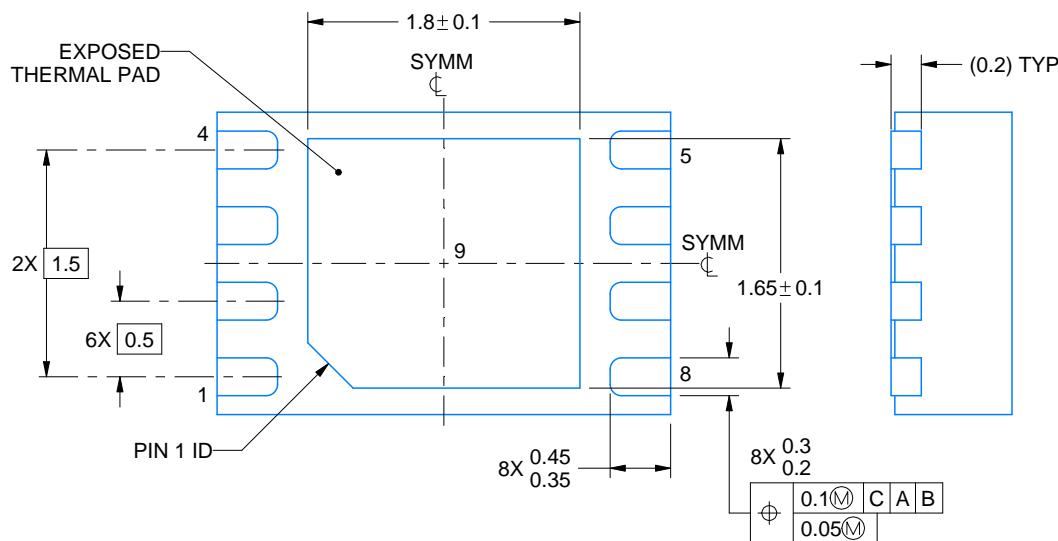
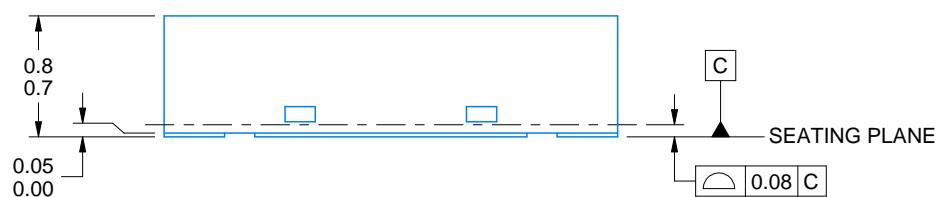
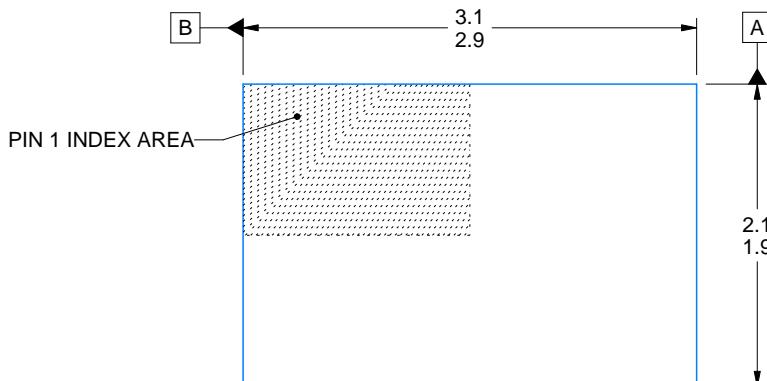
RQX0008A



PACKAGE OUTLINE

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



4225821/A 04/2020

NOTES:

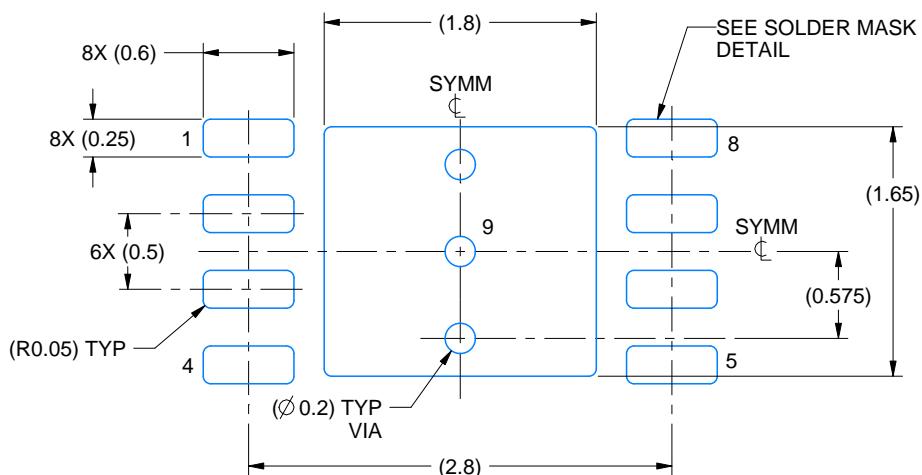
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

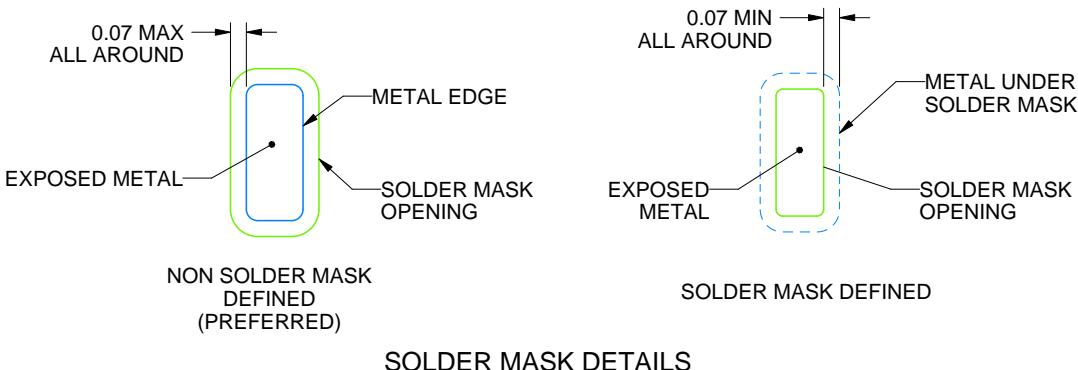
RQX0008A

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 20X



4225821/A 04/2020

NOTES: (continued)

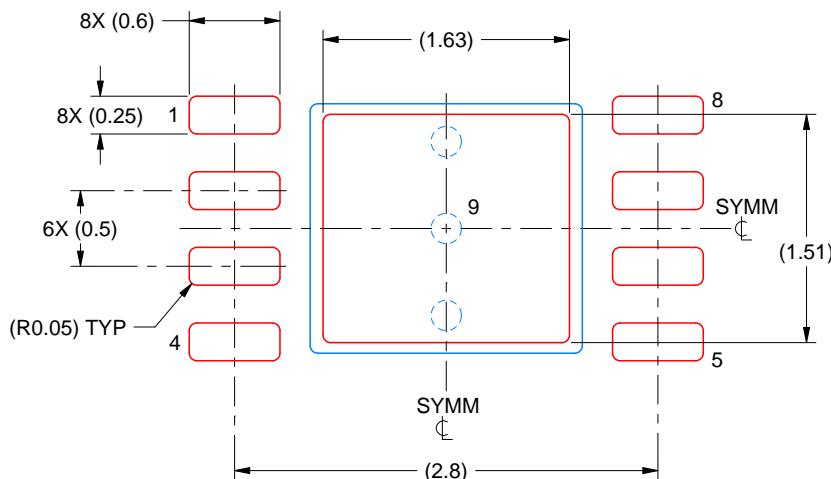
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

RQX0008A

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 20X

EXPOSED PAD 9
83% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

4225821/A 04/2020

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

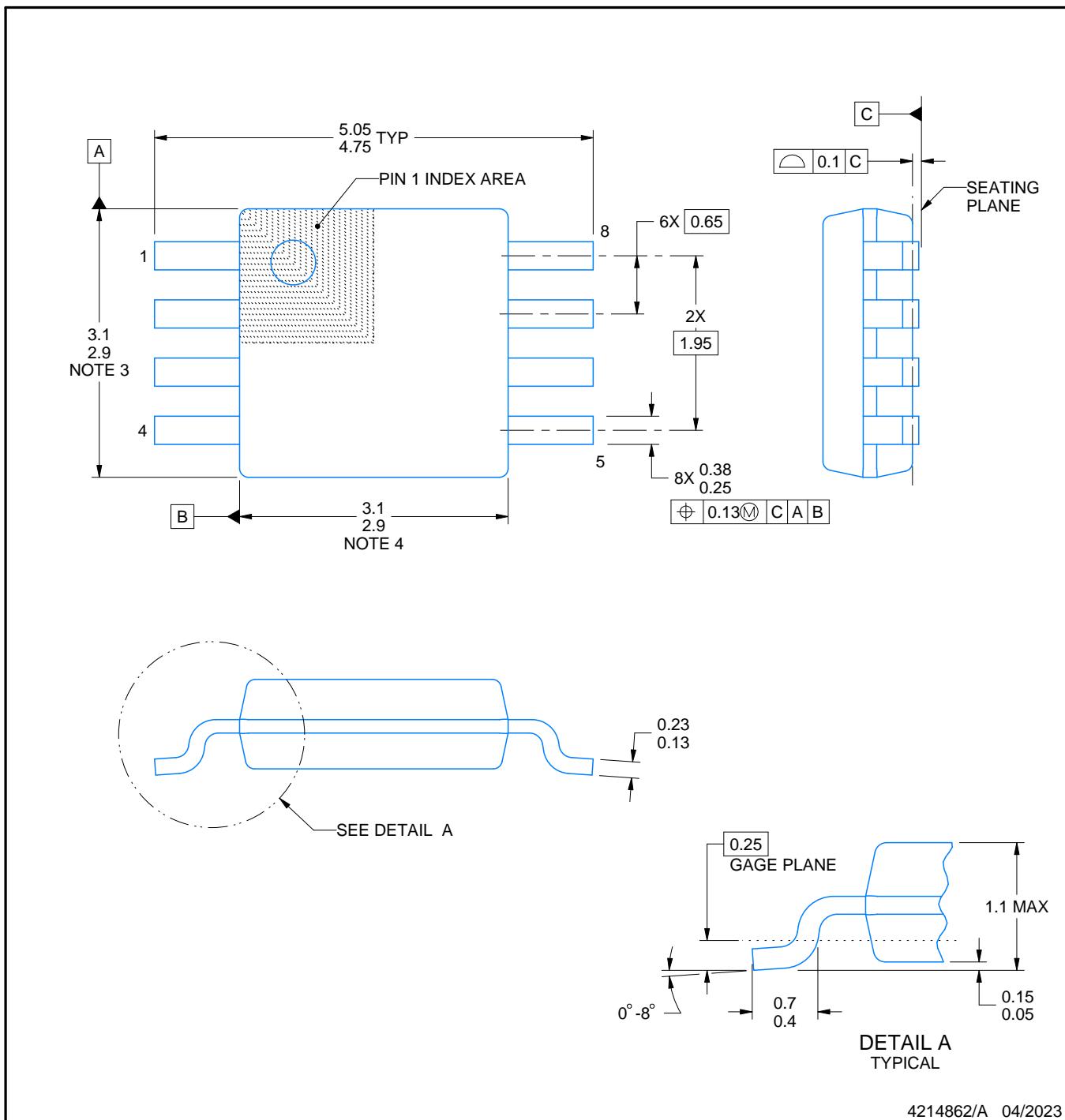
PACKAGE OUTLINE

DGK0008A



VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



NOTES:

PowerPAD is a trademark of Texas Instruments.

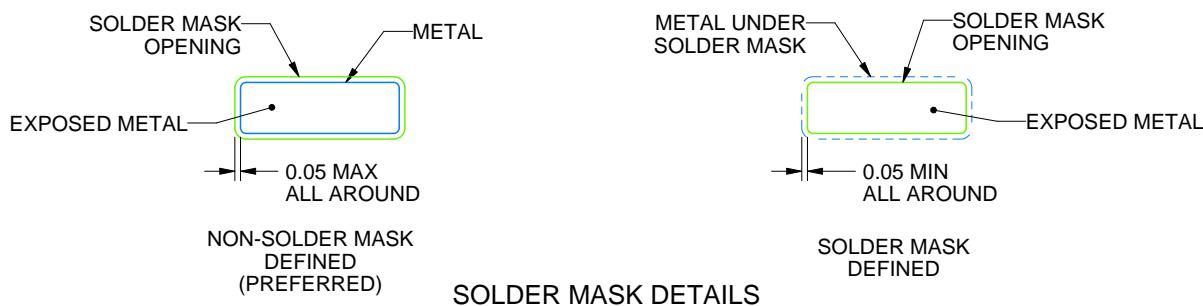
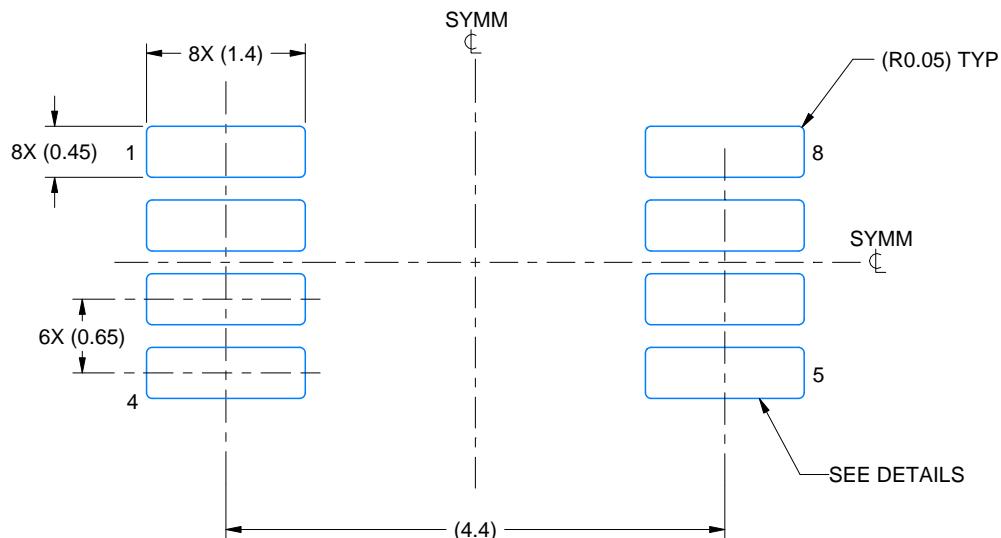
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.

EXAMPLE BOARD LAYOUT

DGK0008A

™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



4214862/A 04/2023

NOTES: (continued)

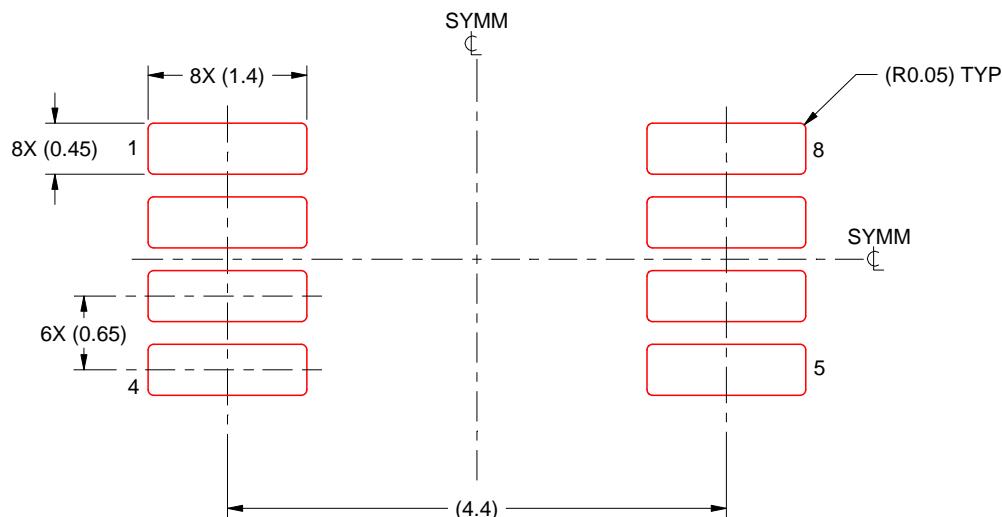
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

EXAMPLE STENCIL DESIGN

DGK0008A

TM VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
SCALE: 15X

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NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.

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